Preliminary Spec.

MH8S72BALD-6

603,979,776-BIT (8,388,608-WORD BY 72-BIT) Synchronous DYNAMIC RAM

PRELIMINARY

Some of contents are subject to change without notice.

DESCRIPTION

The MH8S72BALD is 8388608 - word x 72-bit Synchronous DRAM module. This consist of nine industry standard 8M x 8 Synchronous DRAMs in TSOP.

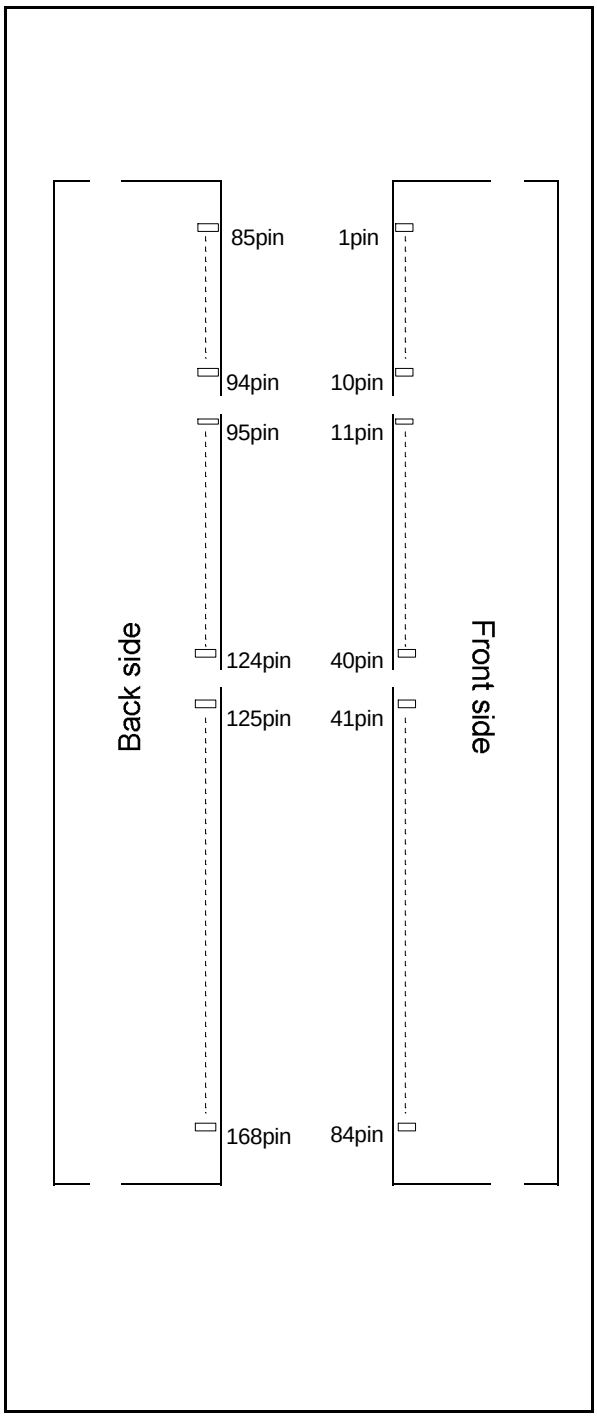
The TSOP on a card edge dual in-line package provides any application where high densities and large of quantities memory are required.

This is a socket-type memory module ,suitable for easy interchange or addition of module.

FEATURES

Type name	Max. Frequency	Access Time from CLK [component level]
MH8S72BALD-6	133MHz	5.4ns (CL = 3)

- **Utilizes industry standard 8M X 8 Synchronous DRAMs in TSOP package**
- **Single 3.3V +/- 0.3V supply**
- **Max.Clock frequency 133MHz**
- **Fully synchronous operation referenced to clock rising edge**
- **4-bank operation controlled by BA0,BA1(Bank Address)**
- **/CAS latency -2/3(programmable,at buffer mode)**
- **LVTTL Interface**
- **Burst length 1/2/4/8/Full Page(programmable)**
- **Burst type- Sequential and interleave burst (programmable)**
- **Random column access**
- **Burst Write / Single Write(programmable)**
- **Auto precharge / All bank precharge controlled by A10**
- **Auto refresh and Self refresh**
- **4096 refresh cycles every 64ms**



APPLICATION

Main memory or graphic memory in computer systems

Preliminary Spec.

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603,979,776-BIT (8,388,608-WORD BY 72-BIT) Synchronous DYNAMIC RAM

PIN NO.	PIN NAME	PIN NO.	PIN NAME	PIN NO.	PIN NAME	PIN NO.	PIN NAME
1	VSS	43	VSS	85	VSS	127	VSS
2	DQ0	44	NC	86	DQ32	128	CKE0
3	DQ1	45	/S2	87	DQ33	129	NC
4	DQ2	46	DQMB2	88	DQ34	130	DQMB6
5	DQ3	47	DQMB3	89	DQ35	131	DQMB7
6	VDD	48	NC	90	VDD	132	NC
7	DQ4	49	VDD	91	DQ36	133	VDD
8	DQ5	50	NC	92	DQ37	134	NC
9	DQ6	51	NC	93	DQ38	135	NC
10	DQ7	52	CB2	94	DQ39	136	CB6
11	DQ8	53	CB3	95	DQ40	137	CB7
12	VSS	54	VSS	96	VSS	138	VSS
13	DQ9	55	DQ16	97	DQ41	139	DQ48
14	DQ10	56	DQ17	98	DQ42	140	DQ49
15	DQ11	57	DQ18	99	DQ43	141	DQ50
16	DQ12	58	DQ19	100	DQ44	142	DQ51
17	DQ13	59	VDD	101	DQ45	143	VDD
18	VDD	60	DQ20	102	VDD	144	DQ52
19	DQ14	61	NC	103	DQ46	145	NC
20	DQ15	62	NC	104	DQ47	146	NC
21	CB0	63	NC	105	CB4	147	NC
22	CB1	64	VSS	106	CB5	148	VSS
23	VSS	65	DQ21	107	VSS	149	DQ53
24	NC	66	DQ22	108	NC	150	DQ54
25	NC	67	DQ23	109	NC	151	DQ55
26	VDD	68	VSS	110	VDD	152	VSS
27	/WE	69	DQ24	111	/CAS	153	DQ56
28	DQMB0	70	DQ25	112	DQMB4	154	DQ57
29	DQMB1	71	DQ26	113	DQMB5	155	DQ58
30	/S0	72	DQ27	114	NC	156	DQ59
31	NC	73	VDD	115	/RAS	157	VDD
32	VSS	74	DQ28	116	VSS	158	DQ60
33	A0	75	DQ29	117	A1	159	DQ61
34	A2	76	DQ30	118	A3	160	DQ62
35	A4	77	DQ31	119	A5	161	DQ63
36	A6	78	VSS	120	A7	162	VSS
37	A8	79	CK2	121	A9	163	CK3
38	A10	80	NC	122	BA0	164	NC
39	BA1	81	WP	123	A11	165	SA0
40	VDD	82	SDA	124	VDD	166	SA1
41	VDD	83	SCL	125	CK1	167	SA2
42	CK0	84	VDD	126	NC	168	VDD

NC = No Connection

Preliminary Spec.

MH8S72BALD-6

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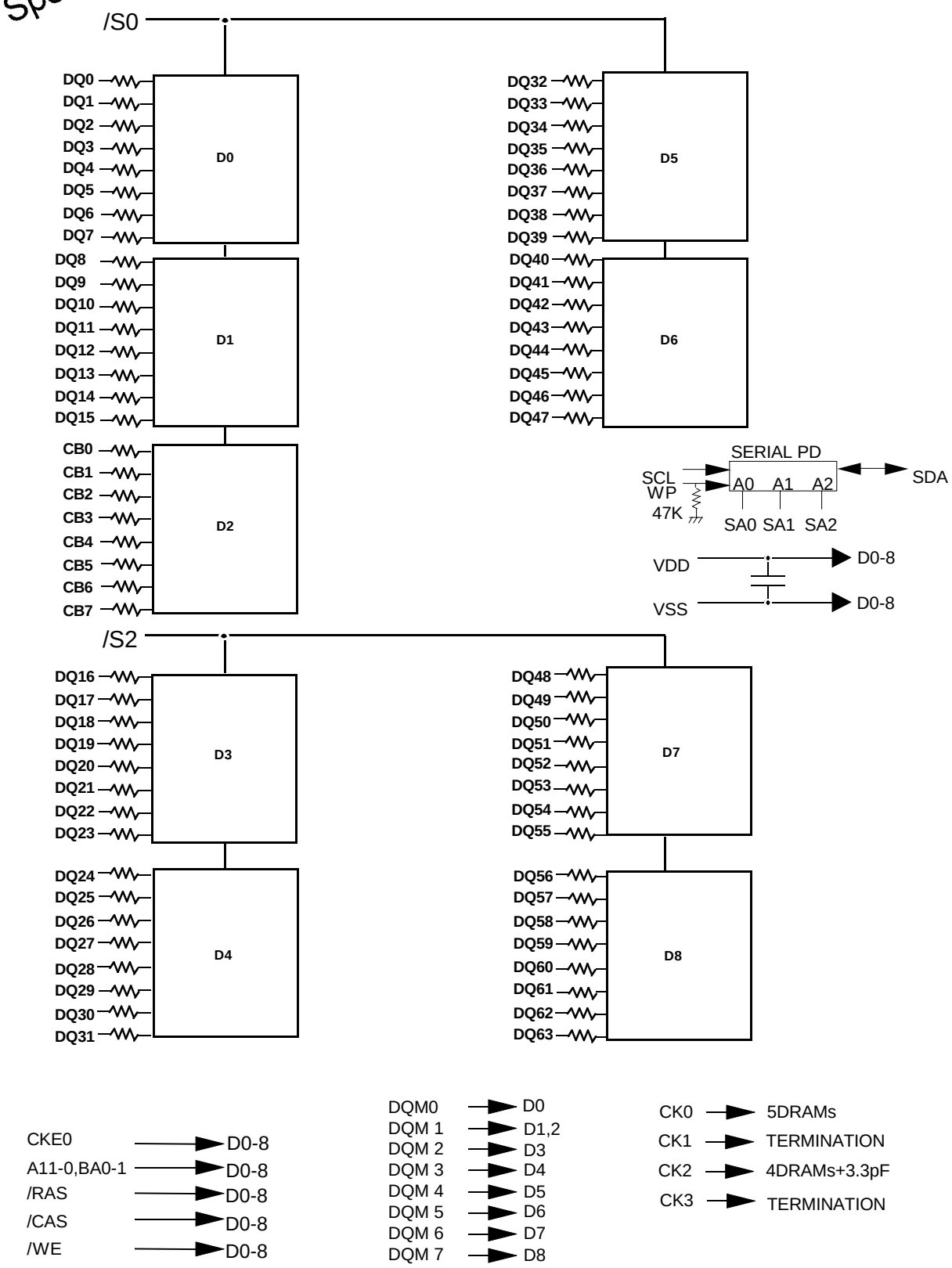


PIN FUNCTION

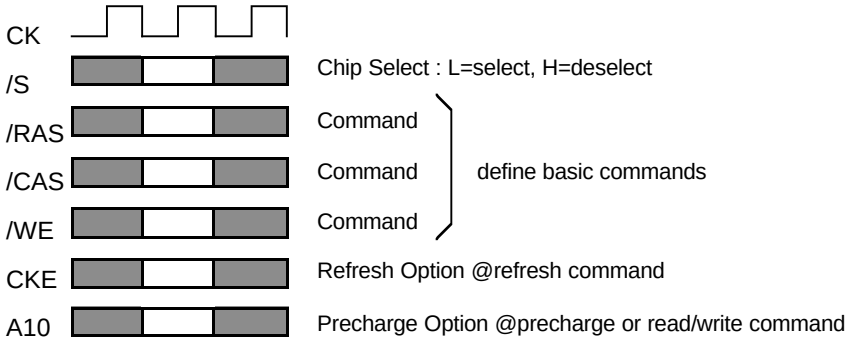
CK0,2	Input	Master Clock:All other inputs are referenced to the rising edge of CK
CKE0	Input	Clock Enable:CKE controls internal clock.When CKE is low,internal clock for the following cycle is ceased. CKE is also used to select auto / self refresh. After self refresh mode is started, CKE E becomes asynchronous input.Self refresh is maintained as long as CKE is low.
/S0,2	Input	Chip Select: When /S is high,any command means No Operation.
/RAS,/CAS,/W	Input	Combination of /RAS,/CAS,/W defines basic commands.
A0-11	Input	A0-11 specify the Row/Column Address in conjunction with BA.The Row Address is specified by A0-11.The Column Address is specified by A0-8.A10 is also used to indicate precharge option.When A10 is high at a read / write command, an auto precharge is performed. When A10 is high at a precharge command, both banks are precharged.
BA0-1	Input	Bank Address:BA0,1 is specifies the four bank to which a command is applied.BA must be set with ACT ,PRE ,READ ,WRITE commands
DQ0-63 CB0-7	Input/Output	Data In and Data out are referenced to the rising edge of CK
DQM0-7	Input	Din Mask/Output Disable:When DQMB is high in burst write.Din for the current cycle is masked.When DQMB is high in burst read,Dout is disabled at the next but one cycle.
Vdd,Vss	Power Supply	Power Supply for the memory mounted module.

BASIC FUNCTIONS

The MH8S72BALD provides basic functions,bank(row)activate,burst read / write, bank(row)precharge,and auto / self refresh.

Each command is defined by control signals of /RAS,/CAS and /WE at CK rising edge. In addition to 3 signals,/S,CKE and A10 are used as chip select,refresh option,and precharge option,respectively.

To know the detailed definition of commands please see the command truth table.



Activate(ACT) [/RAS =L, /CAS = /WE =H]

ACT command activates a row in an idle bank indicated by BA.

Read(READ) [/RAS =H,/CAS =L, /WE =H]

READ command starts burst read from the active bank indicated by BA.First output data appears after /CAS latency. When A10 =H at this command,the bank is deactivated after the burst read(auto-precharge,**READA**).

Write(WRITE) [/RAS =H, /CAS = /WE =L]

WRITE command starts burst write to the active bank indicated by BA. Total data length to be written is set by burst length. When A10 =H at this command, the bank is deactivated after the burst write(auto-precharge,**WRITEA**).

Precharge(PRE) [/RAS =L, /CAS =H,/WE =L]

PRE command deactivates the active bank indicated by BA. This command also terminates burst read / write operation. When A10 =H at this command, both banks are deactivated(precharge all, **PREA**).

Auto-Refresh(REFA) [/RAS =/CAS =L, /WE =CKE =H]

PEFA command starts auto-refresh cycle. Refresh address including bank address are generated internally. After this command, the banks are precharged automatically.

COMMAND TRUTH TABLE

COMMAND	MNEMONIC	CKE n-1	CKE n	/S	/RAS	/CAS	/WE	BA0,1	A11	A10	A0-9
Deselect	DESEL	H	X	H	X	X	X	X	X	X	X
No Operation	NOP	H	X	L	H	H	H	X	X	X	X
Row Adress Entry & Bank Activate	ACT	H	X	L	L	H	H	V	V	V	V
Single Bank Precharge	PRE	H	X	L	L	H	L	V	X	L	X
Precharge All Bank	PREA	H	X	L	L	H	L	X	X	H	X
Column Address Entry & Write	WRITE	H	X	L	H	L	L	V	X	L	V
Column Address Entry & Write with Auto-Precharge	WRITEA	H	X	L	H	L	L	V	X	H	V
Column Address Entry & Read	READ	H	X	L	H	L	H	V	X	L	V
Column Address Entry & Read with Auto Precharge	READA	H	X	L	H	L	H	V	X	H	V
Auto-Refresh	REFA	H	H	L	L	L	H	X	X	X	X
Self-Refresh Entry	REFS	H	L	L	L	L	H	X	X	X	X
Self-Refresh Exit	REFSX	L	H	H	X	X	X	X	X	X	X
		L	H	L	H	H	H	X	X	X	X
Burst Terminate	TBST	H	X	L	H	H	L	X	X	X	X
Mode Register Set	MRS	H	X	L	L	L	L	L	L	L	V*1

H =High Level, L = Low Level, V = Valid, X = Don't Care, n = CK cycle number

NOTE:

1.A7-9 = 0, A0-6 = Mode Address

Preliminary Spec.

FUNCTION TRUTH TABLE

Current State	/S	/RAS	/CAS	/WE	Address	Command	Action
IDLE	H	X	X	X	X	DESEL	NOP
	L	H	H	H	X	NOP	NOP
	L	H	H	L	BA	TBST	ILLEGAL*2
	L	H	L	X	BA,CA,A10	READ/WRITE	ILLEGAL*2
	L	L	H	H	BA,RA	ACT	Bank Active,Latch RA
	L	L	H	L	BA,A10	PRE/PREA	NOP*4
	L	L	L	H	X	REFA	Auto-Refresh*5
	L	L	L	L	Op-Code, Mode-Add	MRS	Mode Register Set*5
ROW ACTIVE	H	X	X	X	X	DESEL	NOP
	L	H	H	H	X	NOP	NOP
	L	H	H	L	BA	TBST	NOP
	L	H	L	H	BA,CA,A10	READ/READA	Begin Read,Latch CA, Determine Auto-Precharge
	L	H	L	L	BA,CA,A10	WRITE/ WRITEA	Begin Write,Latch CA, Determine Auto-Precharge
	L	L	H	H	BA,RA	ACT	Bank Active/ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	Precharge/Precharge All
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL
READ	H	X	X	X	X	DESEL	NOP(Continue Burst to END)
	L	H	H	H	X	NOP	NOP(Continue Burst to END)
	L	H	H	L	BA	TBST	Terminate Burst
	L	H	L	H	BA,CA,A10	READ/READA	Terminate Burst,Latch CA, Begin New Read,Determine Auto-Precharge*3
	L	H	L	L	BA,CA,A10	WRITE/WRITEA	Terminate Burst,Latch CA, Begin Write,Determine Auto-Precharge*3
	L	L	H	H	BA,RA	ACT	Bank Active/ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	Terminate Burst,Precharge
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL

FUNCTION TRUTH TABLE(continued)

Current State	/S	/RAS	/CAS	/WE	Address	Command	Action
WRITE	H	X	X	X	X	DESEL	NOP(Continue Burst to END)
	L	H	H	H	X	NOP	NOP(Continue Burst to END)
	L	H	H	L	BA	TBST	Terminate Burst
	L	H	L	H	BA,CA,A10	READ/READA	Terminate Burst,Latch CA, Begin Read,Determine Auto-Precharge*3
	L	H	L	L	BA,CA,A10	WRITE/ WRITEA	Terminate Burst,Latch CA, Begin Write,Determine Auto-Precharge*3
	L	L	H	H	BA,RA	ACT	Bank Active/ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	Terminate Burst,Precharge
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL
READ with AUTO PRECHARGE	H	X	X	X	X	DESEL	NOP(Continue Burst to END)
	L	H	H	H	X	NOP	NOP(Continue Burst to END)
	L	H	H	L	BA	TBST	ILLEGAL
	L	H	L	H	BA,CA,A10	READ/READA	ILLEGAL
	L	H	L	L	BA,CA,A10	WRITE/ WRITEA	ILLEGAL
	L	L	H	H	BA,RA	ACT	Bank Active/ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	ILLEGAL*2
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL
WRITE with AUTO PRECHARGE	H	X	X	X	X	DESEL	NOP(Continue Burst to END)
	L	H	H	H	X	NOP	NOP(Continue Burst to END)
	L	H	H	L	BA	TBST	ILLEGAL
	L	H	L	H	BA,CA,A10	READ/READA	ILLEGAL
	L	H	L	L	BA,CA,A10	WRITE/ WRITEA	ILLEGAL
	L	L	H	H	BA,RA	ACT	Bank Active/ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	ILLEGAL*2
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL

FUNCTION TRUTH TABLE(continued)

Current State	/S	/RAS	/CAS	/WE	Address	Command	Action
PRE - CHARGING	H	X	X	X	X	DESEL	NOP(Idle after tRP)
	L	H	H	H	X	NOP	NOP(Idle after tRP)
	L	H	H	L	BA	TBST	ILLEGAL*2
	L	H	L	X	BA,CA,A10	READ/WRITE	ILLEGAL*2
	L	L	H	H	BA,RA	ACT	ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	NOP*4(Idle after tRP)
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL
ROW ACTIVATING	H	X	X	X	X	DESEL	NOP(Row Active after tRCD
	L	H	H	H	X	NOP	NOP(Row Active after tRCD
	L	H	H	L	BA	TBST	ILLEGAL*2
	L	H	L	X	BA,CA,A10	READ/WRITE	ILLEGAL*2
	L	L	H	H	BA,RA	ACT	ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	ILLEGAL*2
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL
WRITE RE-COVERING	H	X	X	X	X	DESEL	NOP
	L	H	H	H	X	NOP	NOP
	L	H	H	L	BA	TBST	ILLEGAL*2
	L	H	L	X	BA,CA,A10	READ/WRITE	ILLEGAL*2
	L	L	H	H	BA,RA	ACT	ILLEGAL*2
	L	L	H	L	BA,A10	PRE/PREA	ILLEGAL*2
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL

FUNCTION TRUTH TABLE(continued)

Current State	/S	/RAS	/CAS	/WE	Address	Command	Action
RE-	H	X	X	X	X	DESEL	NOP(Idle after tRC)
FRESHING	L	H	H	H	X	NOP	NOP(Idle after tRC)
	L	H	H	L	BA	TBST	ILLEGAL
	L	H	L	X	BA,CA,A10	READ/WRITE	ILLEGAL
	L	L	H	H	BA,RA	ACT	ILLEGAL
	L	L	H	L	BA,A10	PRE/PREA	ILLEGAL
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL
MODE	H	X	X	X	X	DESEL	NOP(Idle after tRSC)
REGISTER	L	H	H	H	X	NOP	NOP(Idle after tRSC)
SETTING	L	H	H	L	BA	TBST	ILLEGAL
	L	H	L	X	BA,CA,A10	READ/WRITE	ILLEGAL
	L	L	H	H	BA,RA	ACT	ILLEGAL
	L	L	H	L	BA,A10	PRE/PREA	ILLEGAL
	L	L	L	H	X	REFA	ILLEGAL
	L	L	L	L	Op-Code, Mode-Add	MRS	ILLEGAL

ABBREVIATIONS:

H = Hige Level, L = Low Level, X = Don't Care

BA = Bank Address, RA = Row Address, CA = Column Address, NOP = No Operation

NOTES:

1. All entries assume that CKE was High during the preceding clock cycle and the current clock cycle.
2. ILLEGAL to bank in specified state; function may be legal in the bank indicated by BA, depending on the state of that bank.
3. Must satisfy bus contention, bus turn around, write recovery requirements.
4. NOP to bank precharging or in idle state.May precharge bank indicated by BA.
5. ILLEGAL if any bank is not idle.

ILLEGAL = Device operation and / or date-integrity are not guaranteed.

Preliminary Spec.

FUNCTION TRUTH TABLE FOR CKE

Current State	CKE n-1	CKE n	/S	/RAS	/CAS	/WE	Add	Action
SELF - REFRESH*1	H	X	X	X	X	X	X	INVALID
	L	H	H	X	X	X	X	Exit Self-Refresh(Idle after tRC)
	L	H	L	H	H	H	X	Exit Self-Refresh(Idle after tRC)
	L	H	L	H	H	L	X	ILLEGAL
	L	H	L	H	L	X	X	ILLEGAL
	L	H	L	L	X	X	X	ILLEGAL
	L	L	X	X	X	X	X	NOP(Maintain Self-Refresh)
POWER DOWN	H	X	X	X	X	X	X	INVALID
	L	H	X	X	X	X	X	Exit Power Down to Idle
	L	L	X	X	X	X	X	NOP(Maintain Self-Refresh)
ALL BANKS IDLE*2	H	H	X	X	X	X	X	Refer to Function Truth Table
	H	L	L	L	L	H	X	Enter Self-Refresh
	H	L	H	X	X	X	X	Enter Power Down
	H	L	L	H	H	H	X	Enter Power Down
	H	L	L	H	H	L	X	ILLEGAL
	H	L	L	H	L	X	X	ILLEGAL
	H	L	L	L	X	X	X	ILLEGAL
	L	X	X	X	X	X	X	Refer to Current State = Power Down
ANY STATE other than listed above	H	H	X	X	X	X	X	Refer to Function Truth Table
	H	L	X	X	X	X	X	Begin CK0 Suspend at Next Cycle*3
	L	H	X	X	X	X	X	Exit CK0 Suspend at Next Cycle*3
	L	L	X	X	X	X	X	Maintain CK0 Suspend

ABBREVIATIONS:
H = High Level, L = Low Level, X = Don't Care

NOTES:
1. CKE Low to High transition will re-enable CK and other inputs **asynchronously**.
   A minimum setup time must be satisfied before any command other than EXIT.
2. Power-Down and Self-Refresh can be entered only form the All banks idle State.
3. Must be legal command.

POWER ON SEQUENCE

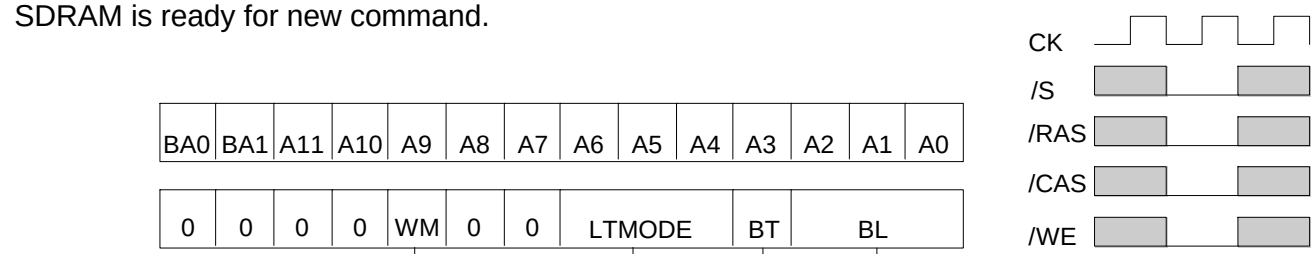
Before starting normal operation, the following power on sequence is necessary to prevent a SDRAM from damaged or malfunctioning.

1. Clock will be applied at power up along with power. Attempt to maintain CKE high, DQMB high and NOP condition at the inputs along with power.
2. Maintain stable power, stable cock, and NOP input conditions for a minimum of 200µs.
3. Issue precharge commands for all banks. (PRE or PREA)
4. After all banks become idle state (after tRP), issue 8 or more auto-refresh commands.
5. Issue a mode register set command to initialize the mode register.

After these sequence, the SDRAM is idle state and ready for normal operation.

MODE REGISTER

Burst Length, Burst Type and /CAS Latency can be programmed by setting the mode register(MRS). The mode register stores these date until the next MRS command, which may be issue when both banks are in idle state. After tRSC from a MRS command, the SDRAM is ready for new command.



BA0	BA1	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0
0	0	0	0	WM	0	0	LTMODE			BT	BL		

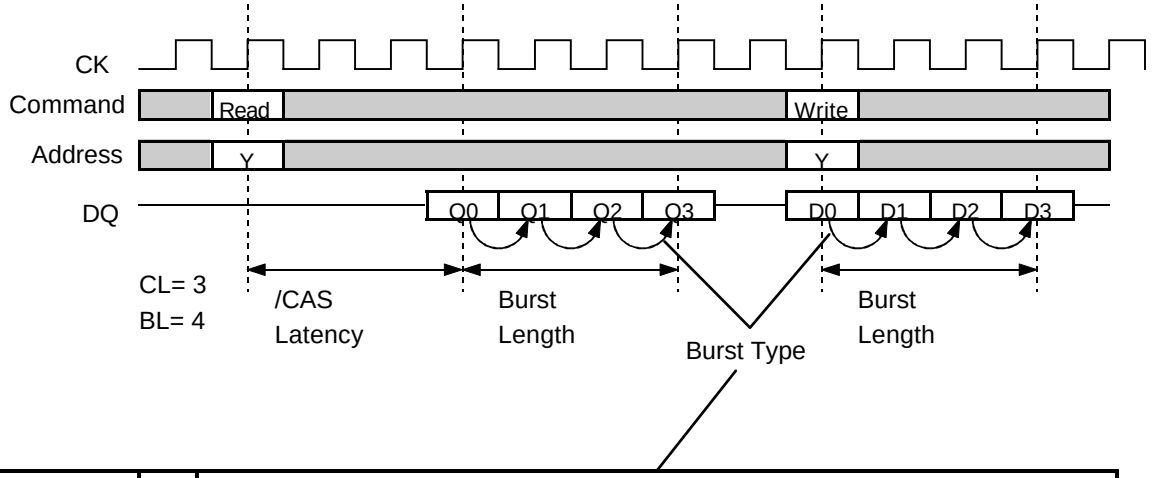
	CL	/CAS LATENCY
LATENCY MODE	0 0 0	R
	0 0 1	R
	0 1 0	2
	0 1 1	3
	1 0 0	R
	1 0 1	R
	1 1 0	R
	1 1 1	R

	BL	BT= 0	BT= 1
BURST LENGTH	0 0 0	1	1
	0 0 1	2	2
	0 1 0	4	4
	0 1 1	8	8
	1 0 0	R	R
	1 0 1	R	R
	1 1 0	R	R
	1 1 1	FP	R

BURST TYPE	0	SEQUENTIAL
	1	INTERLEAVED

WRITE MODE	0	BURST
	1	SINGLE BIT

R:Reserved for Future Use
FP: Full Page



Initial Address			BL	Column Addressing															
A2	A1	A0		Sequential								Interleaved							
0	0	0	8	0	1	2	3	4	5	6	7	0	1	2	3	4	5	6	7
0	0	1		1	2	3	4	5	6	7	0	1	0	3	2	5	4	7	6
0	1	0		2	3	4	5	6	7	0	1	2	3	0	1	6	7	4	5
0	1	1		3	4	5	6	7	0	1	2	3	2	1	0	7	6	5	4
1	0	0		4	5	6	7	0	1	2	3	4	5	6	7	0	1	2	3
1	0	1		5	6	7	0	1	2	3	4	5	4	7	6	1	0	3	2
1	1	0		6	7	0	1	2	3	4	5	6	7	4	5	2	3	0	1
1	1	1		7	0	1	2	3	4	5	6	7	6	5	4	3	2	1	0
-	0	0	4	0	1	2	3					0	1	2	3				
-	0	1		1	2	3	0					1	0	3	2				
-	1	0		2	3	0	1					2	3	0	1				
-	1	1		3	0	1	2					3	2	1	0				
-	-	0	2	0	1							0	1						
-	-	1		1	0							1	0						

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Condition	Ratings	Unit
Vdd	Supply Voltage	with respect to Vss	-0.5 ~ 4.6	V
VI	Input Voltage	with respect to Vss	-0.5 ~ 4.6	V
VO	Output Voltage	with respect to Vss	-0.5 ~ 4.6	V
IO	Output Current		50	mA
Pd	Power Dissipation	Ta=25C	9	W
Topr	Operating Temperature		0 ~ 70	C
Tstg	Storage Temperature		-45 ~ 100	C

RECOMMENDED OPERATING CONDITION

(Ta=0 ~ 70C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min.	Typ.	Max.	
Vdd	Supply Voltage	3.0	3.3	3.6	V
Vss	Supply Voltage	0	0	0	V
VIH*1	High-Level Input Voltage all inputs	2.0		Vdd+0.3	V
VIL*2	Low-Level Input Voltage all inputs	-0.3		0.8	V

NOTES)

1. VIH(max)=Vdd+2.0V AC for pulse width less than 3ns acceptable.
2. VIL(min)= -2.0V for pulse width less than 3ns acceptable.

CAPACITANCE

(Ta=0 ~ 70C, Vdd = 3.3 +/- 0.3V, Vss = 0V, unless otherwise noted)

Symbol	Parameter	Test Condition	Limits(max.)	Unit
CI(A)	Input Capacitance, address pin	1Mhz 1.4V bias 200mV swing	49.2	pF
CI(C)	Input Capacitance, control pin		49.2	pF
CI(K)	Input Capacitance, CK0 pin		32.5	pF
CI/O	Input Capacitance, I/O pin		16.5	pF

AVERAGE SUPPLY CURRENT from Vdd

(Ta=0 ~70C, Vdd = 3.3 ± 0.3V, Vss = 0V, unless otherwise noted)

Parameter	Symbol	Test Condition	Limits (max)	Unit	Note
operating current single bank operation (discrete)	Icc1	tRC=min.tCLK=min, BL=1, CL=3, IOL=0mA	1080	mA	*1
precharge stanby current in Non power-down mode	Icc2N	CKE=VIHmin,tCLK=15ns	225	mA	*1,2
	Icc2NS	CLK=VILmax, CKE=VIHmin (fixed)	180	mA	*1
precharge stanby current in Power-down mode	Icc2P	CKE=VILmax,tCLK=15ns	18	mA	*1,2
	Icc2PS	CKE=CLK=VILmax (fixed)	9	mA	*1
active stanby current in Non Power Down Mode	Icc3N	CKE= /CS=VIHmin,tCLK=15ns	495	mA	*1,2
	Icc3NS	CKE= /CS=VIHmin,CLK=VILmax (fixed)	360	mA	*1
active stanby current in Power Down Mode	Icc3P	CKE=VILmax,tCLK=15ns	18	mA	*1,2
	Icc3PS	CKE= CLK=VILmax (fixed)	1	mA	*1
burst current	Icc4	tCLK=min, BL=4, CL=3,IOL=0mA all banks active(discerte)	1305	mA	*1
auto-refresh current	Icc5	tRFC=min, tCLK=min	1350	mA	*1
self-refresh current	Icc6	CKE <0.2V	9	mA	*1

Note)

1.Icc(max) is specified at the output open condition.

2.Input single are changed one time during 30ns.

AC OPERATING CONDITIONS AND CHARACTERISTICS

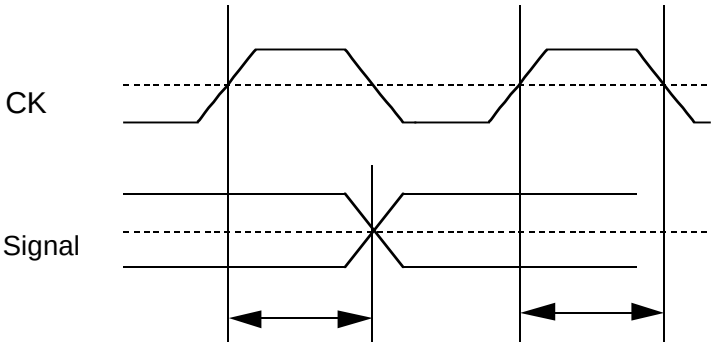
(Ta=0 ~ 70C, Vdd = 3.3 ± 0.3V, Vss = 0V, unless otherwise noted)

Symbol	Parameter	Test Condition	Limits		Unit
			Min.	Max.	
VOH(DC)	High-Level Output Voltage(DC)	IOH=-2mA	2.4		V
VOL(DC)	Low-Level Output Voltage(DC)	IOL=2mA		0.4	V
IOZ	Off-stare Output Current	Q floating VO=0 ~ Vdd	-10	10	uA
Ii	Input Current	VIH=0 ~ Vdd+0.3V	-90	90	uA

AC TIMING REQUIREMENTS

(Ta=0 ~ 70C, Vdd = 3.3 +/- 0.3V, Vss = 0V, unless otherwise noted)
Input Pulse Levels: 0.8V to 2.0V
Input Timing Measurement Level: 1.4V

Symbol	Parameter		Limits		Unit
			Min.	Max.	
tCLK	CK cycle time	CL=3	7.5		ns
		CL=2	-		ns
tCH	CK High pulse width		2.5		ns
tCL	CK Low pulse width		2.5		ns
tT	Transition time of CK		1	10	ns
tIS	Input Setup time(all inputs)		1.5		ns
tIH	Input Hold time(all inputs)		0.8		ns
tRC	Row Cycle time		67.5		ns
tRFC	Row Refresh Cycle time		80		ns
tRCD	Row to Column Delay		22.5		ns
tRAS	Row Active time		45	100K	ns
tRP	Row Precharge time		22.5		ns
tWR	Write Recovery time		15		ns
tRRD	Act to Act Deley time		15		ns
tRSC	Mode Register Set Cycle time		15		ns
tSRX	Self Refresh Exit time		7.5		ns
tPDE	Power Down Exit time		7.5		ns
tREF	Refresh Interval time			64	ms



Any AC timing is referenced to the input signal crossing through 1.4V.

Preliminary Spec.

SWITCHING CHARACTERISTICS

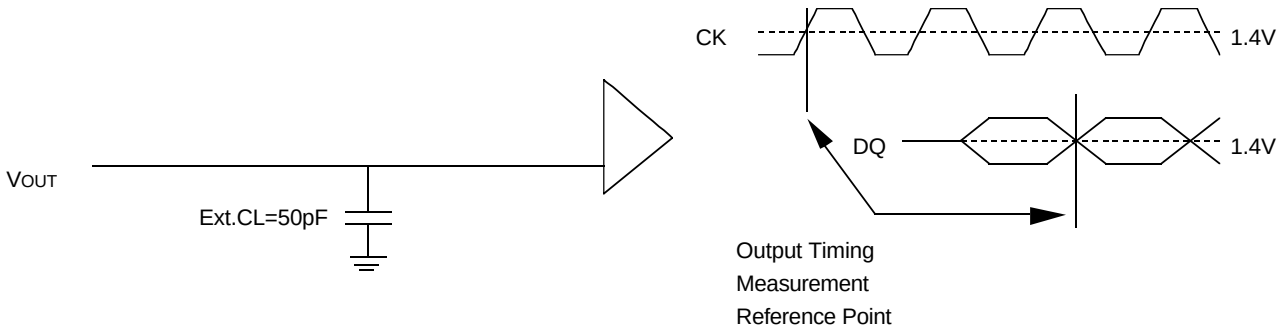
(Ta=0 ~ 70C, Vdd = 3.3 +/- 0.3V, Vss = 0V, unless otherwise noted)

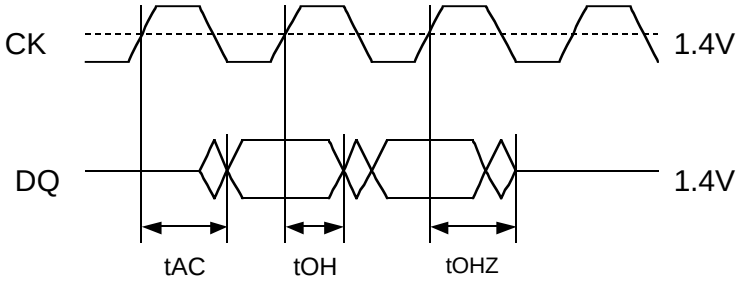
Symbol	Parameter		Limits		Unit	Note
			Min.	Max.		
tAC	Access time from CK	CL=3		5.4	ns	*1
		CL=2		-		
tOH	Output Hold time from CK		2.7		ns	
tOLZ	Delay time, output low impedance from CK		0		ns	
tOHZ	Delay time, output high impedance from CK		2.7	5.4	ns	

NOTE)

1.If clock rising time is longer than 1ns, (tr /2-0.5ns) should be added to the parameter.

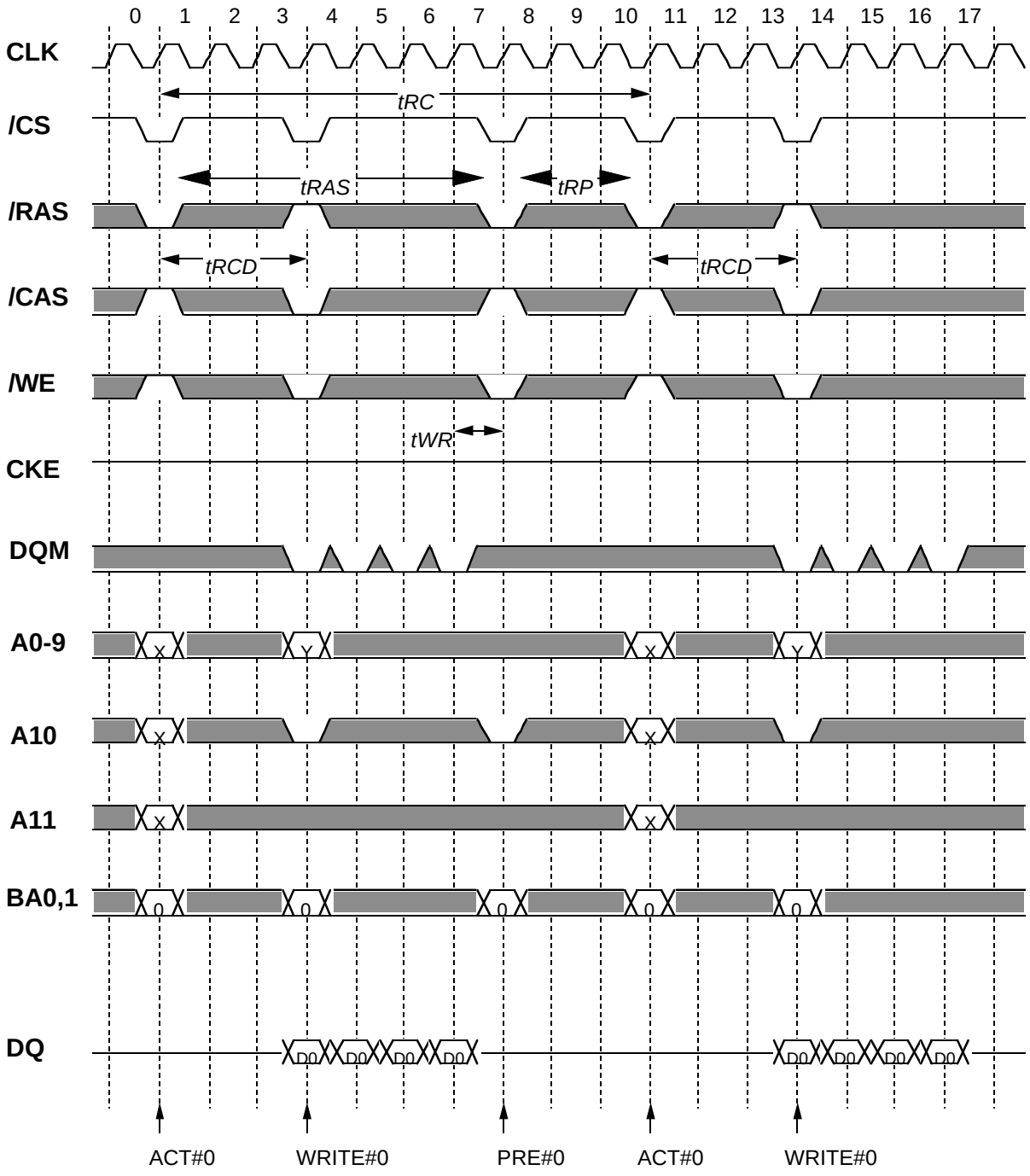
Output Load Condition





Burst WRITE (single bank)

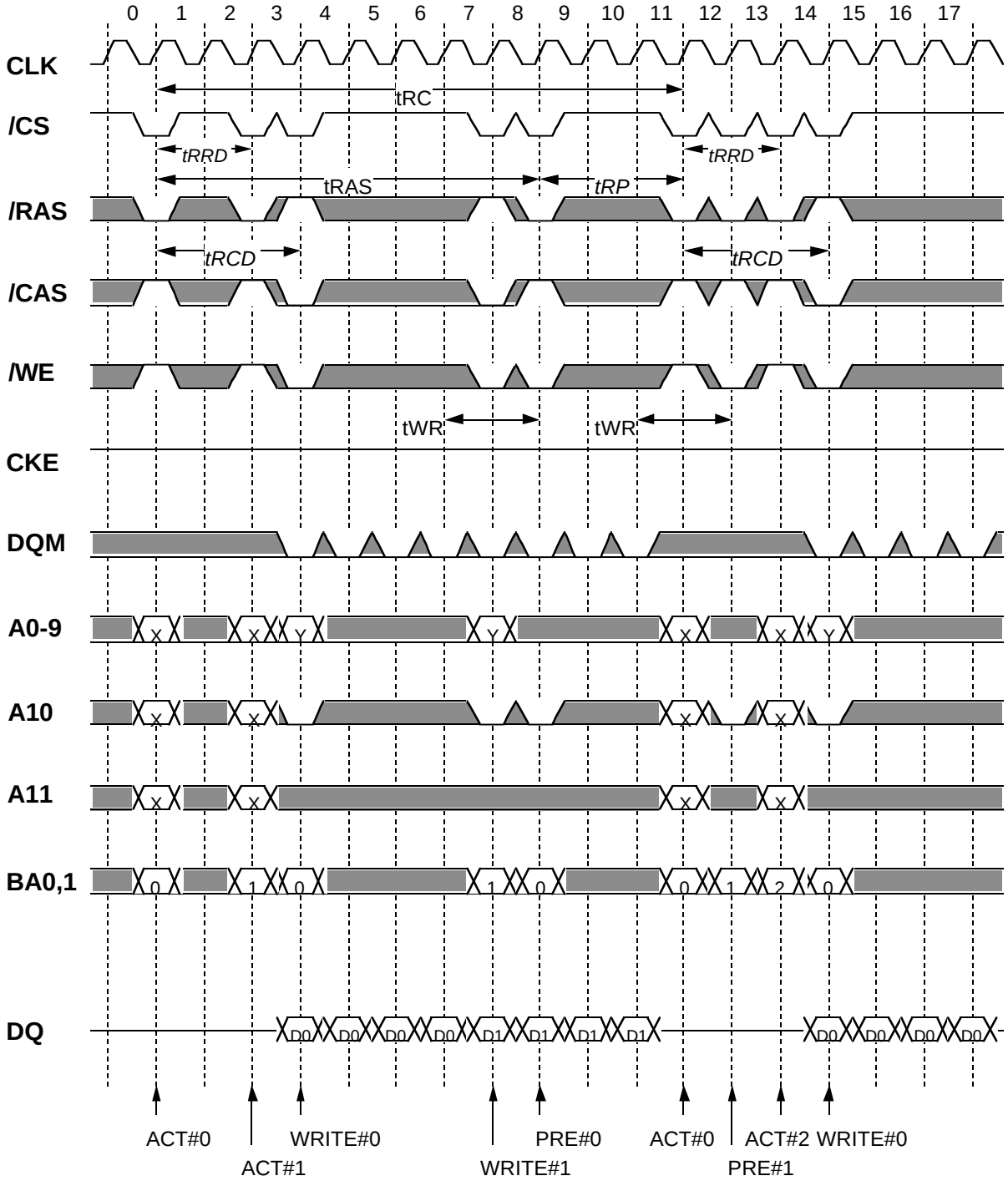
BL=4



Italic parameter indicates minimum case

Burst WRITE (multi bank)

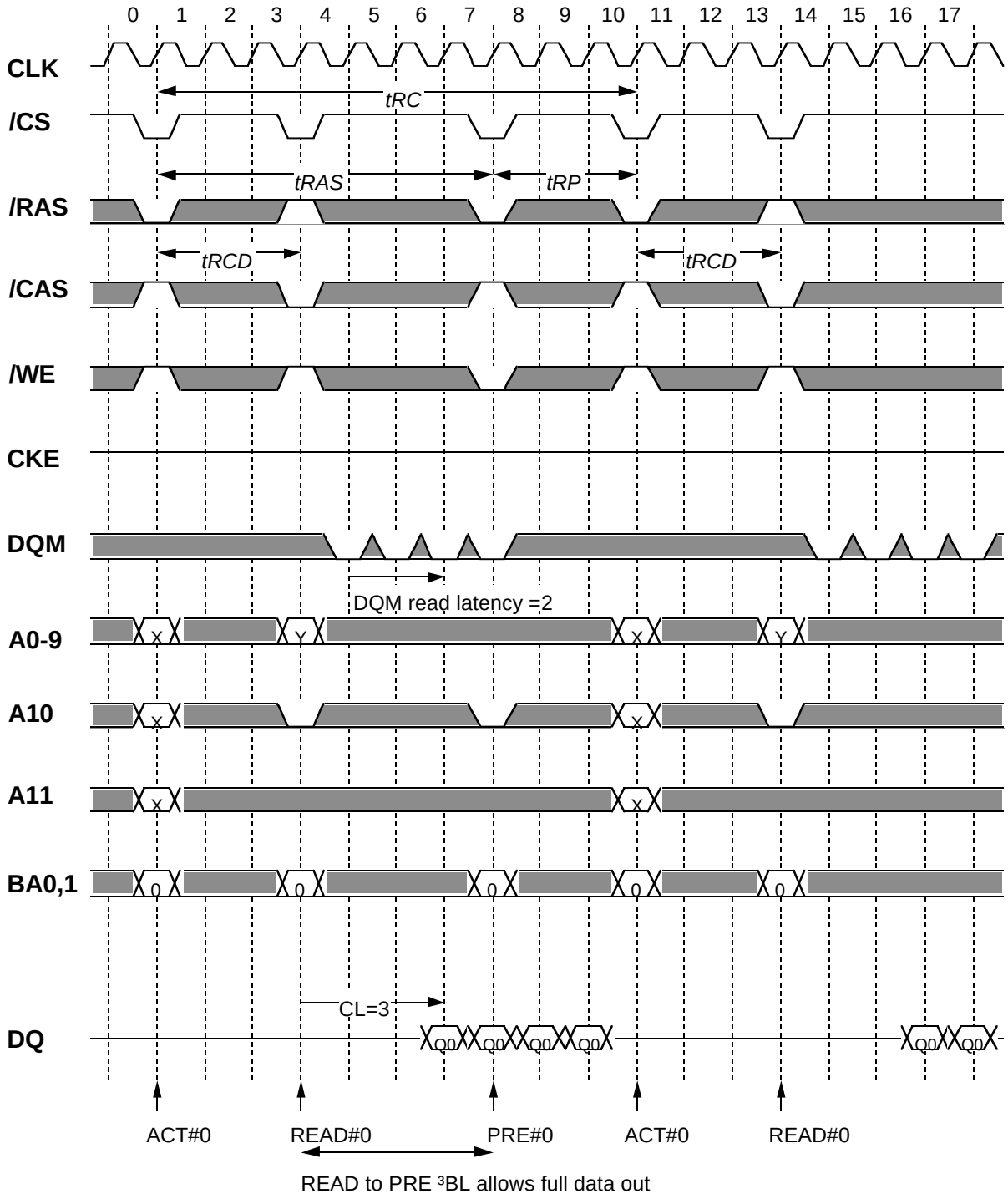
BL=4



Italic parameter indicates minimum case

Burst READ (single bank)

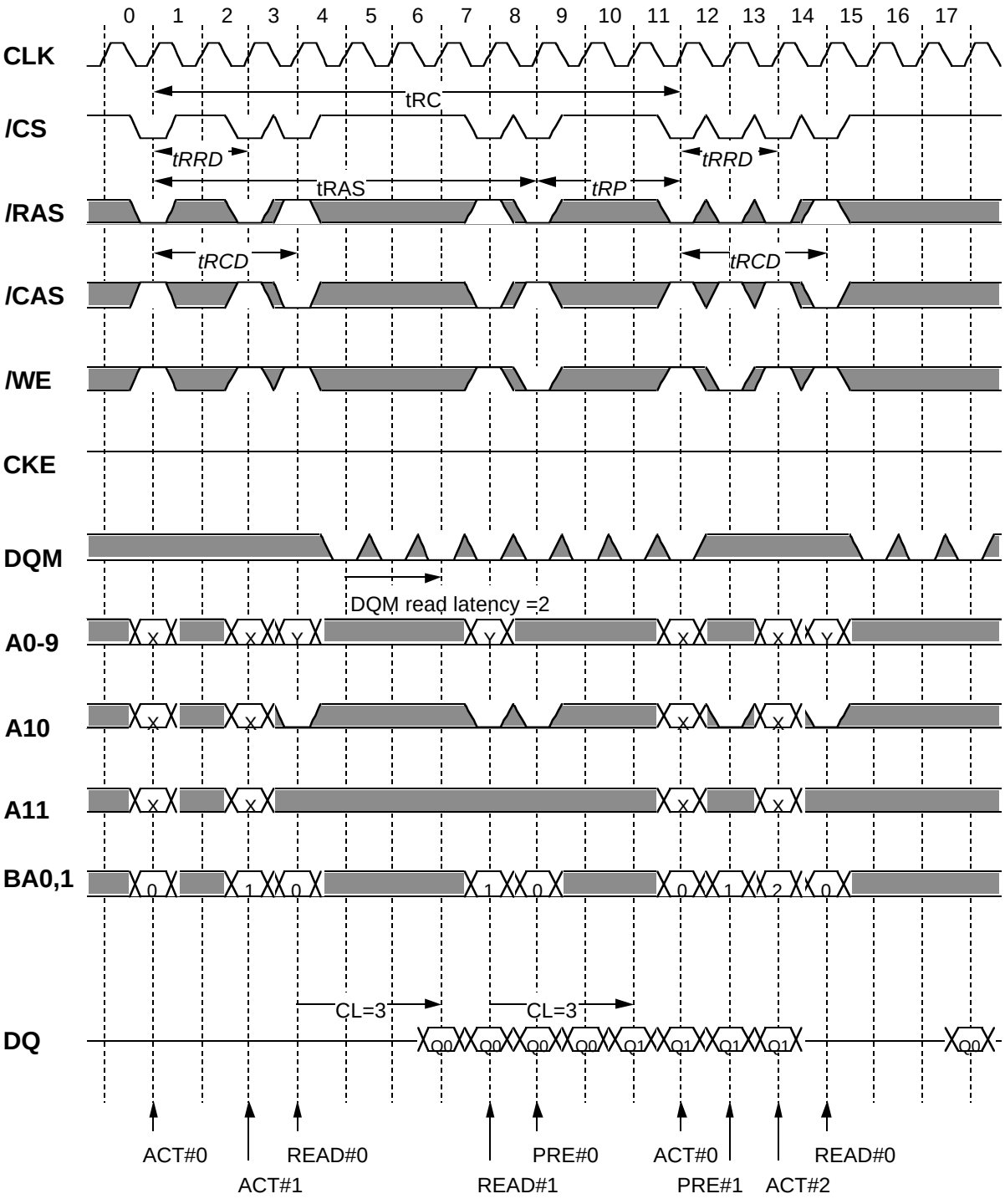
BL=4,CL=3



Italic parameter indicates minimum case

Burst READ (multi bank)

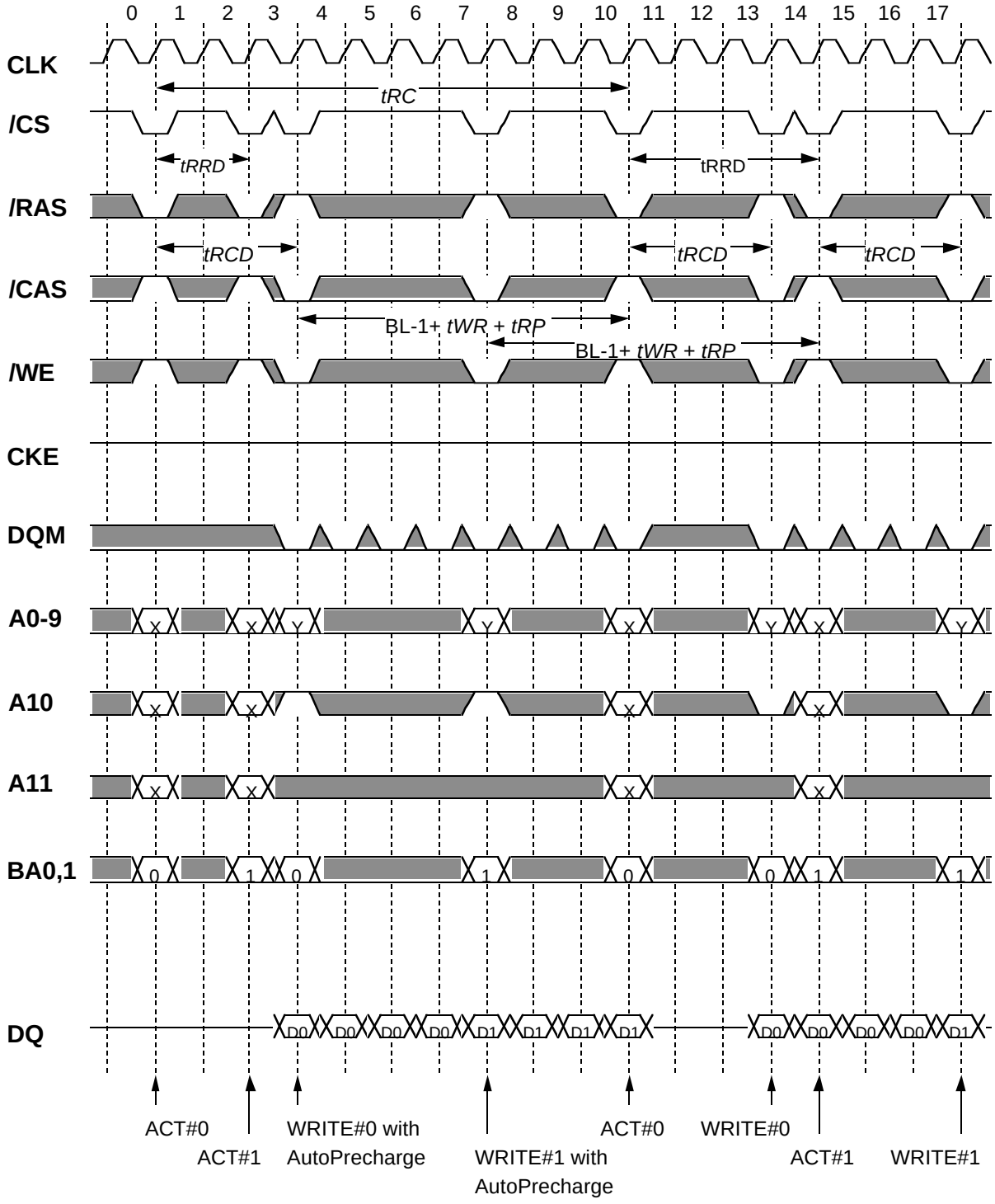
BL=4,CL=3



Italic parameter indicates minimum case

Burst WRITE (multi bank) with AUTO-PRECHARGE

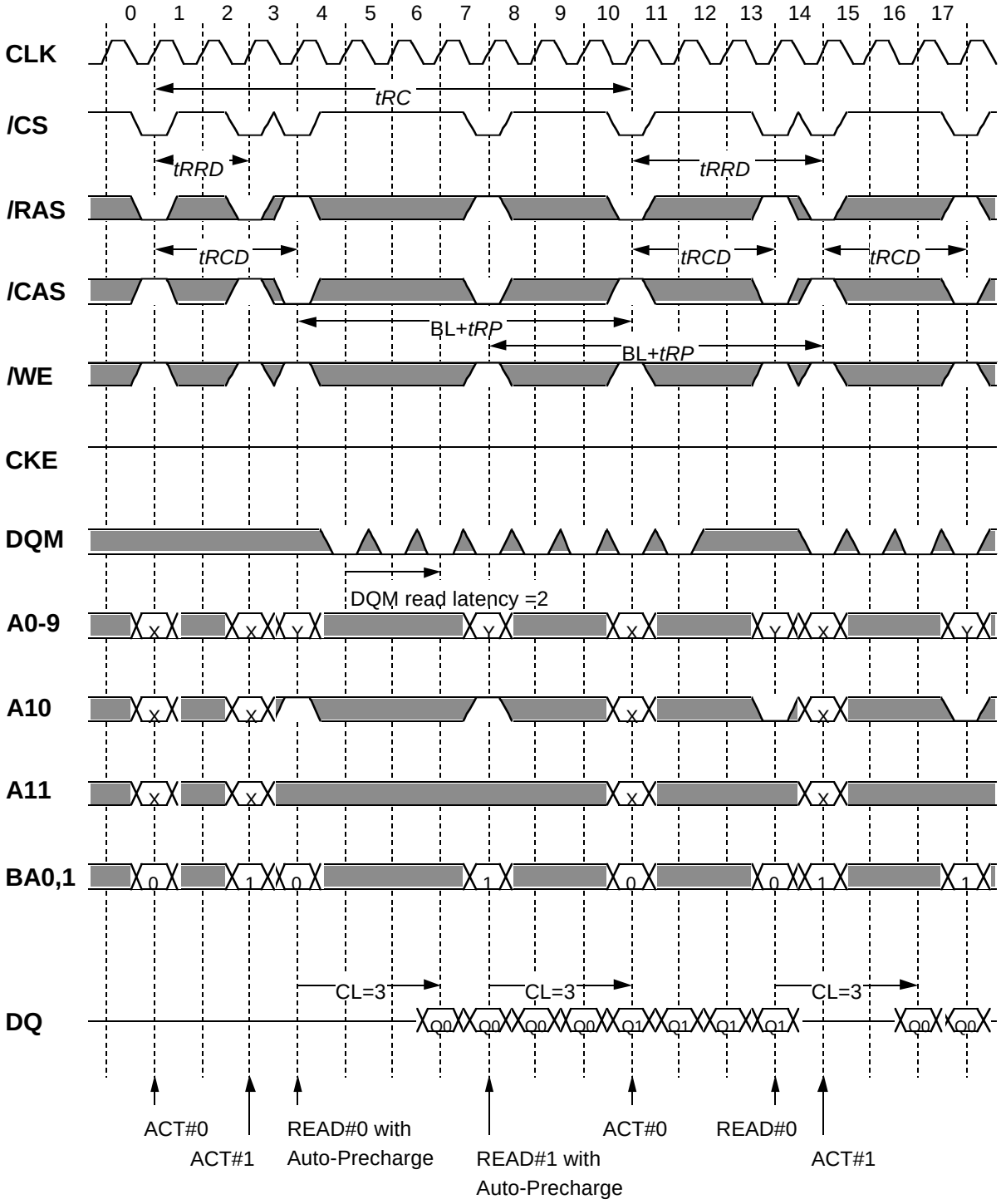
BL=4



Italic parameter indicates minimum case

Burst READ (multi bank) with AUTO-PRECHARGE

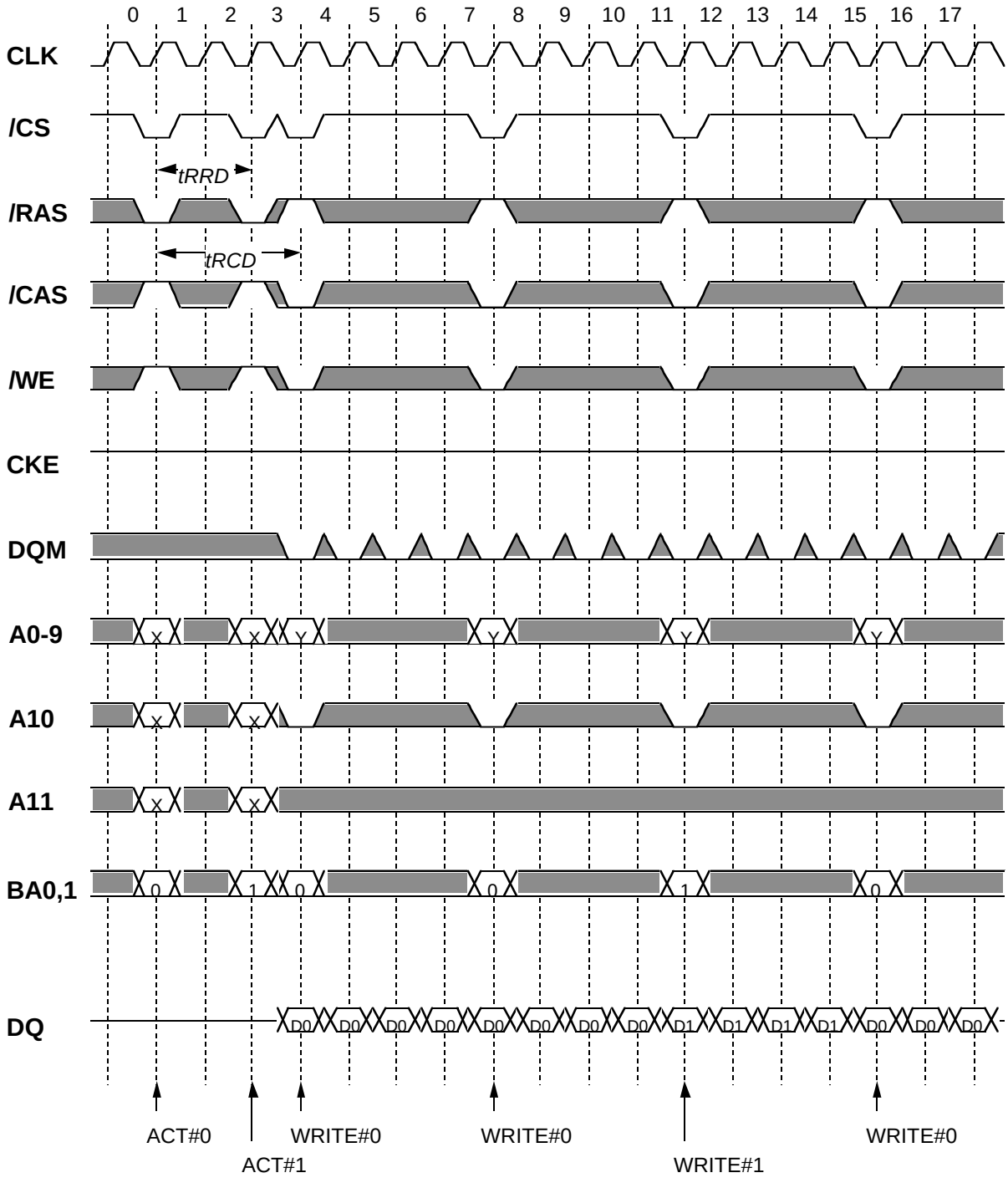
BL=4,CL=3



Italic parameter indicates minimum case

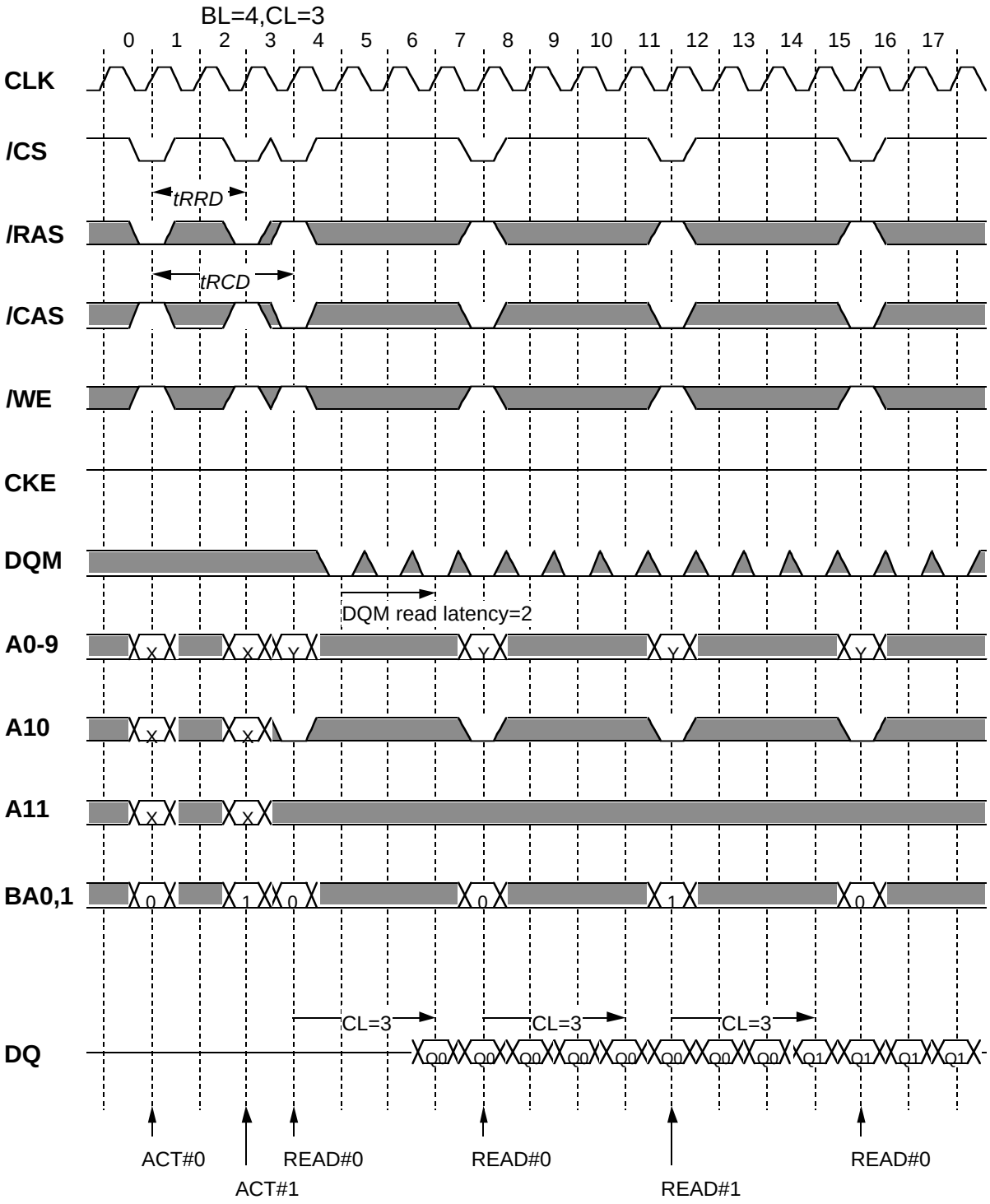
Page Mode Burst Write (multi bank)

BL=4



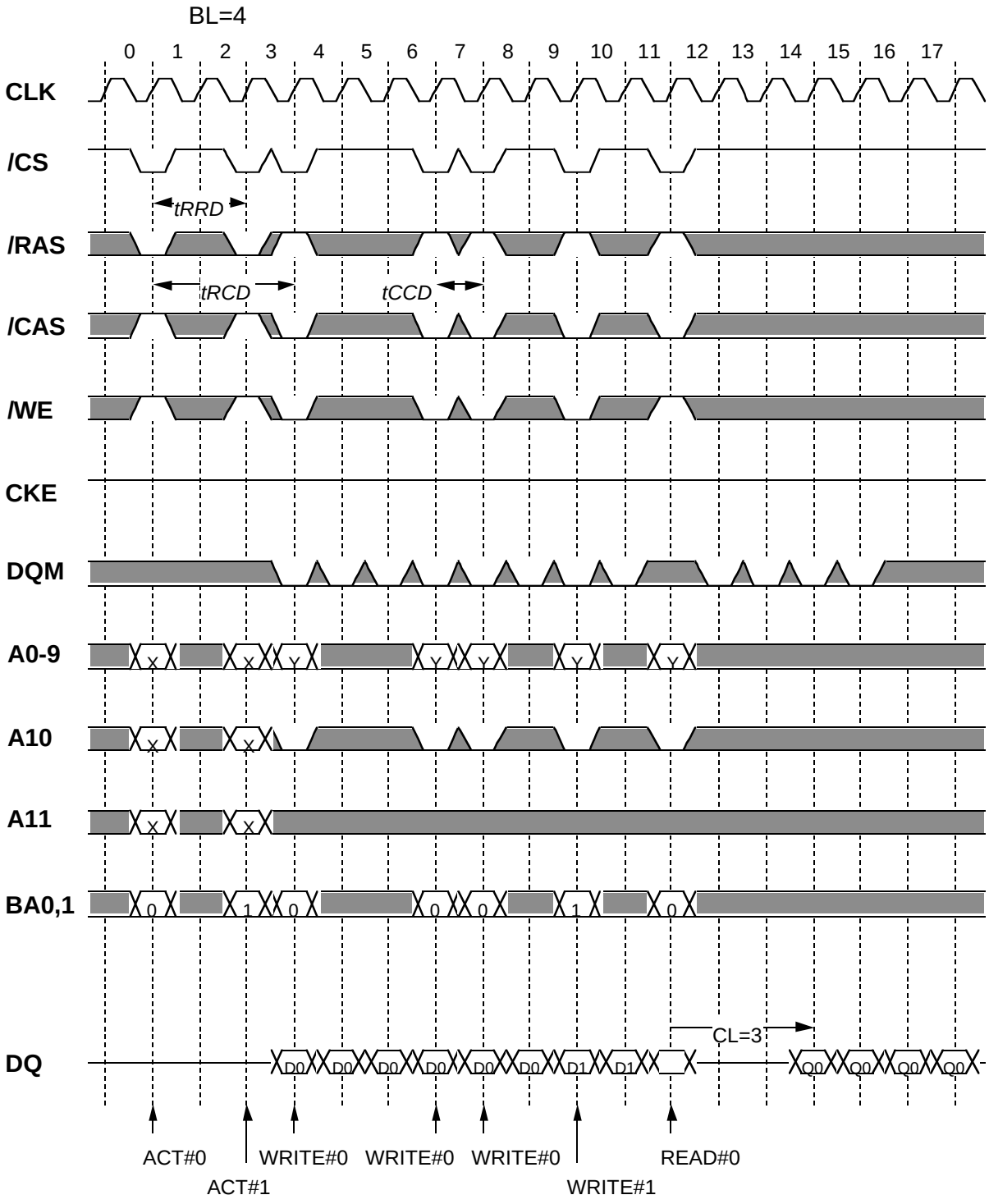
Italic parameter indicates minimum case

Page Mode Burst Read (multi bank)



Italic parameter indicates minimum case

Write Interrupted by Write / Read

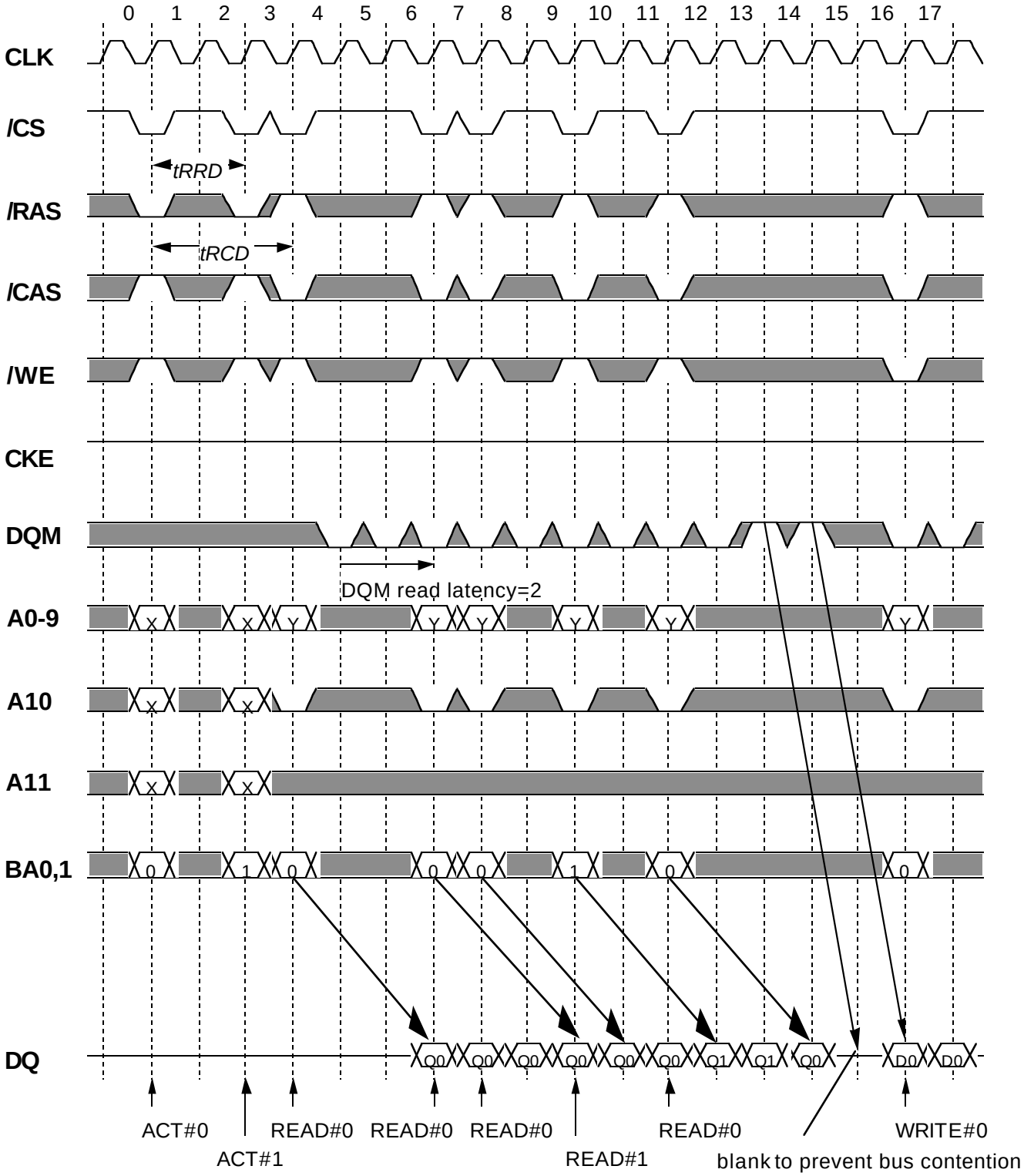


Burst Write can be interrupted by Write or Read of any active bank.

Italic parameter indicates minimum case

Read Interrupted by Read / Write

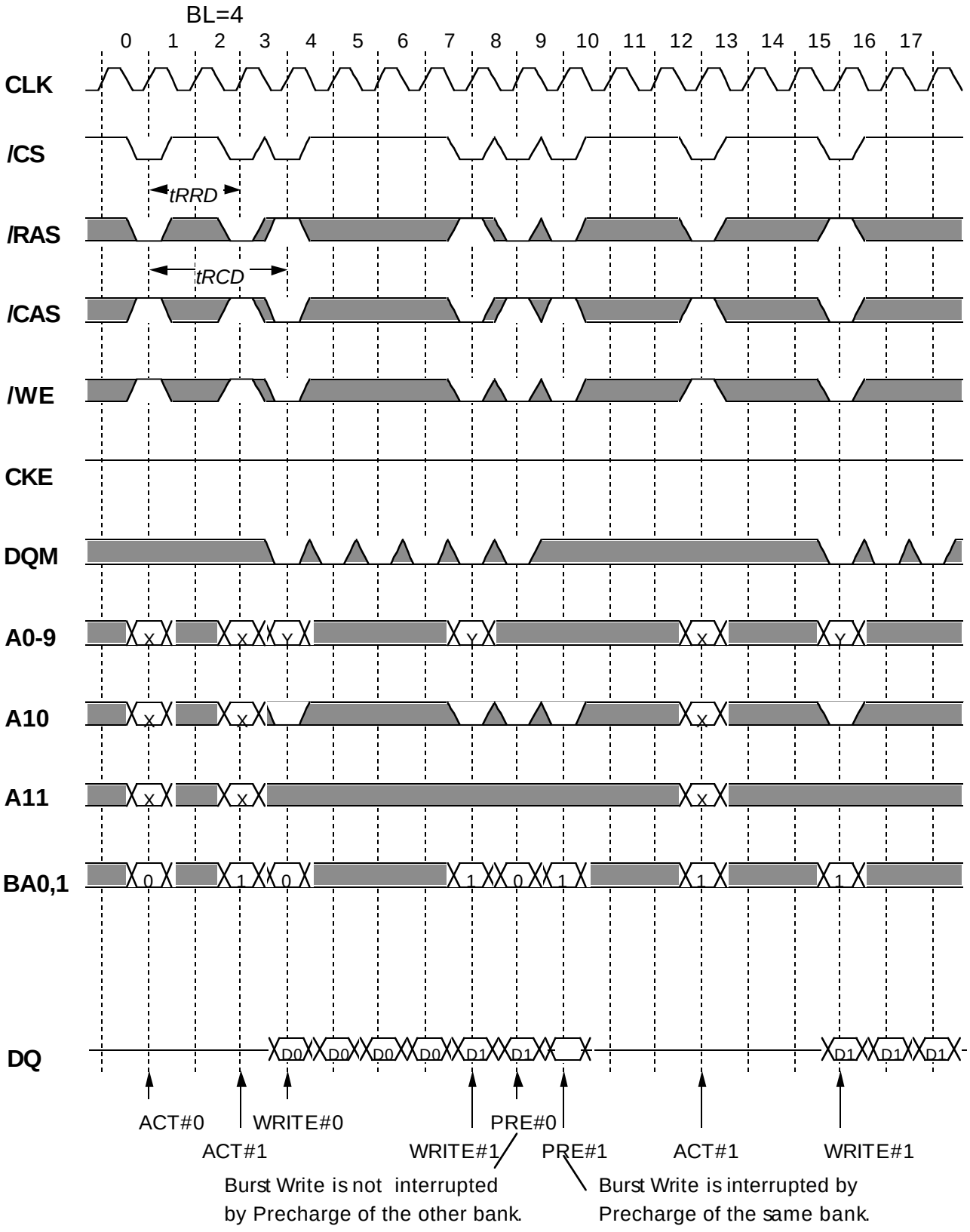
BL=4,CL=3



Burst Read can be interrupted by Read or Write of any active bank.

Italic parameter indicates minimum case

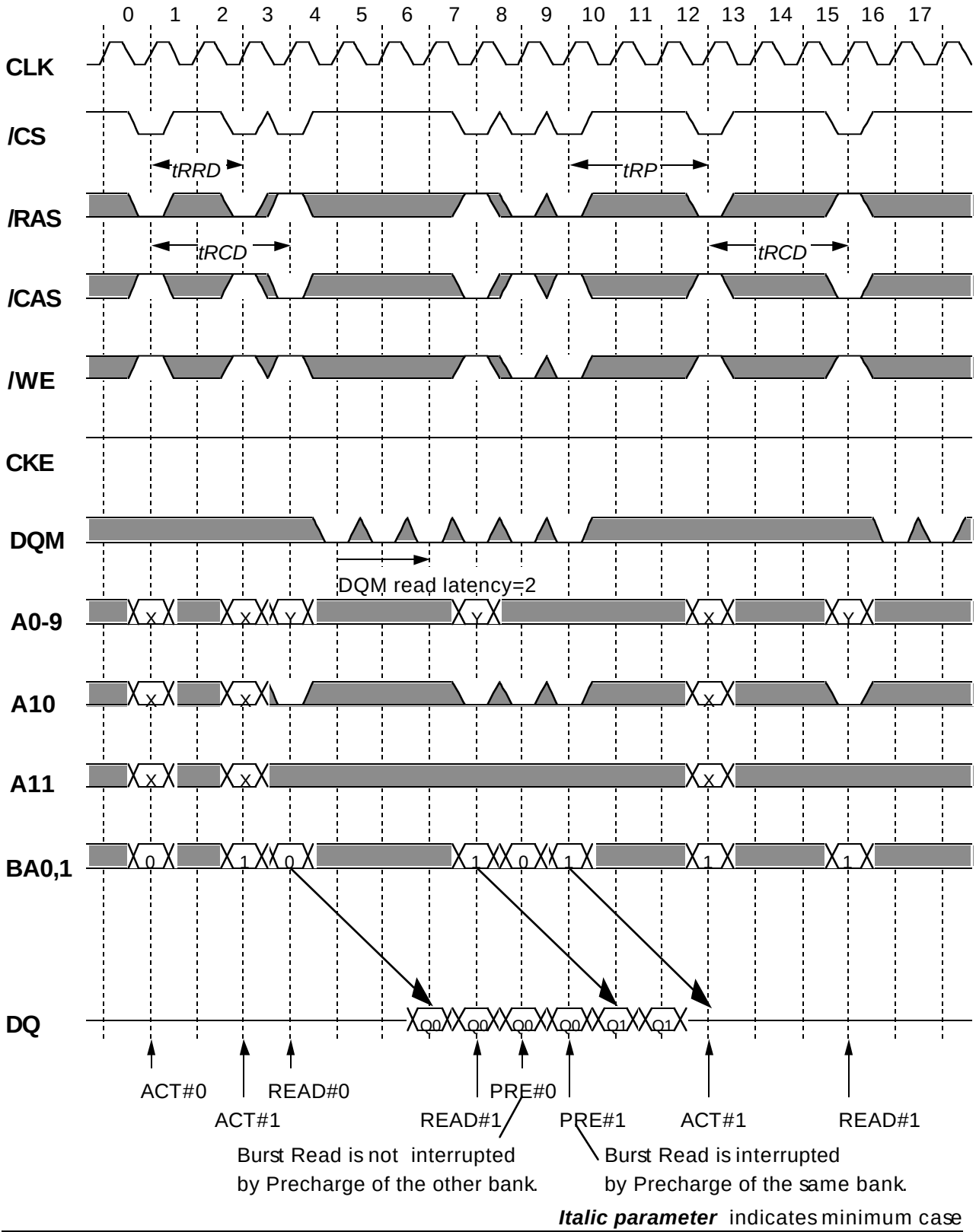
Write Interrupted by Precharge



Italic parameter indicates minimum case

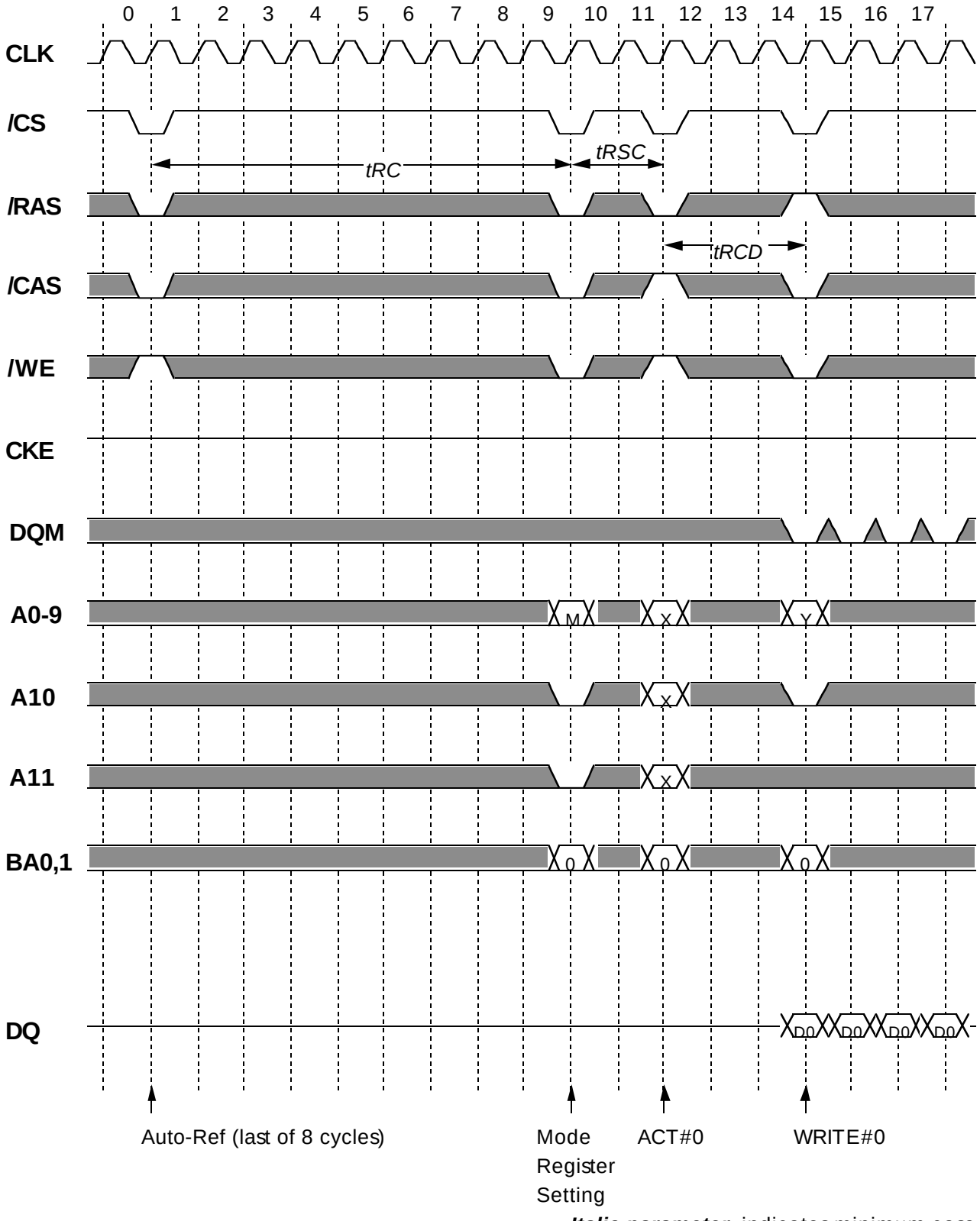
Read Interrupted by Precharge

BL=4,CL=3



Italic parameter indicates minimum case

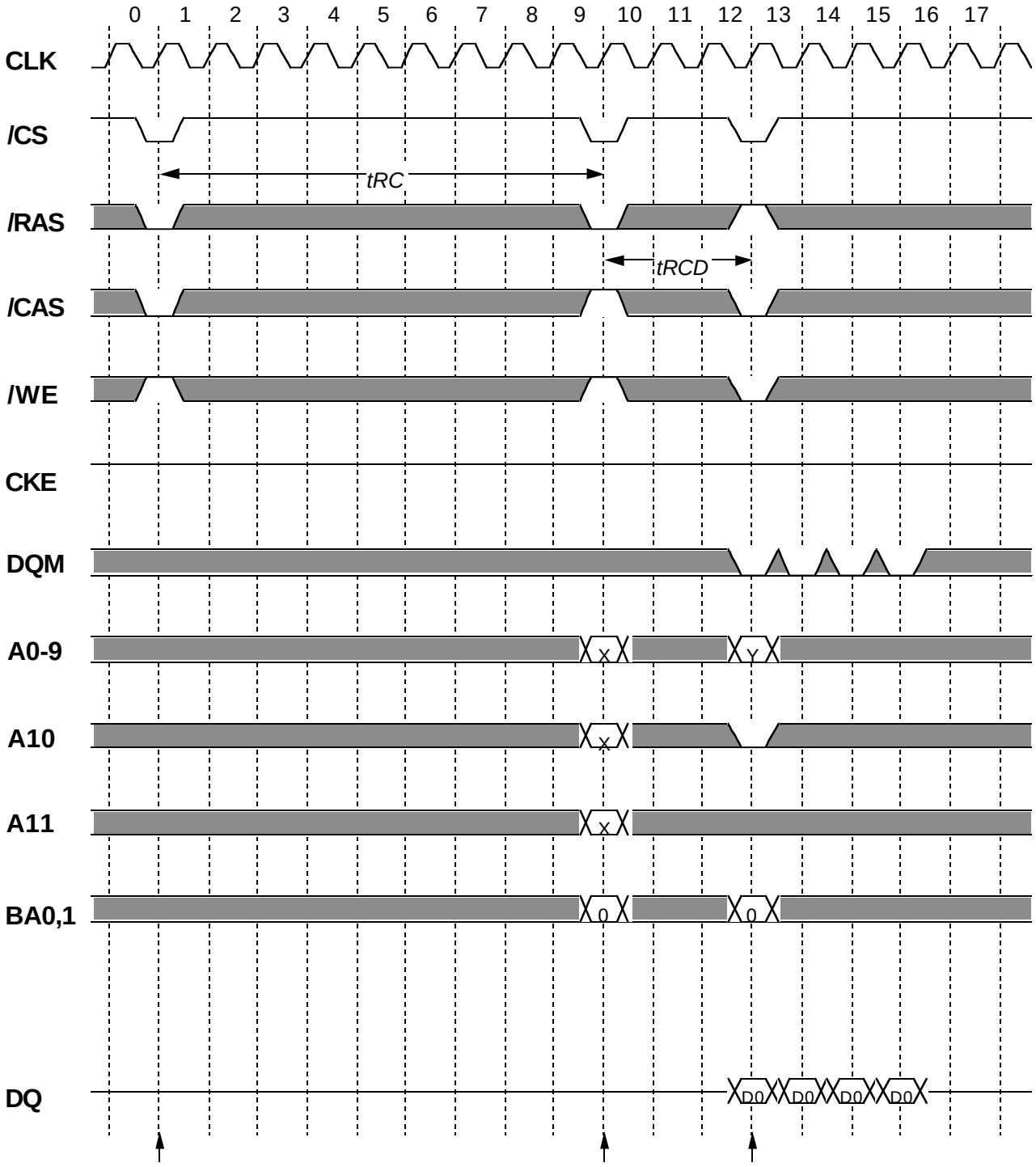
Mode Register Setting



Italic parameter indicates minimum case

Auto-Refresh

BL=4



Auto-Refresh

Before Auto-Refresh, all banks must be idle state.

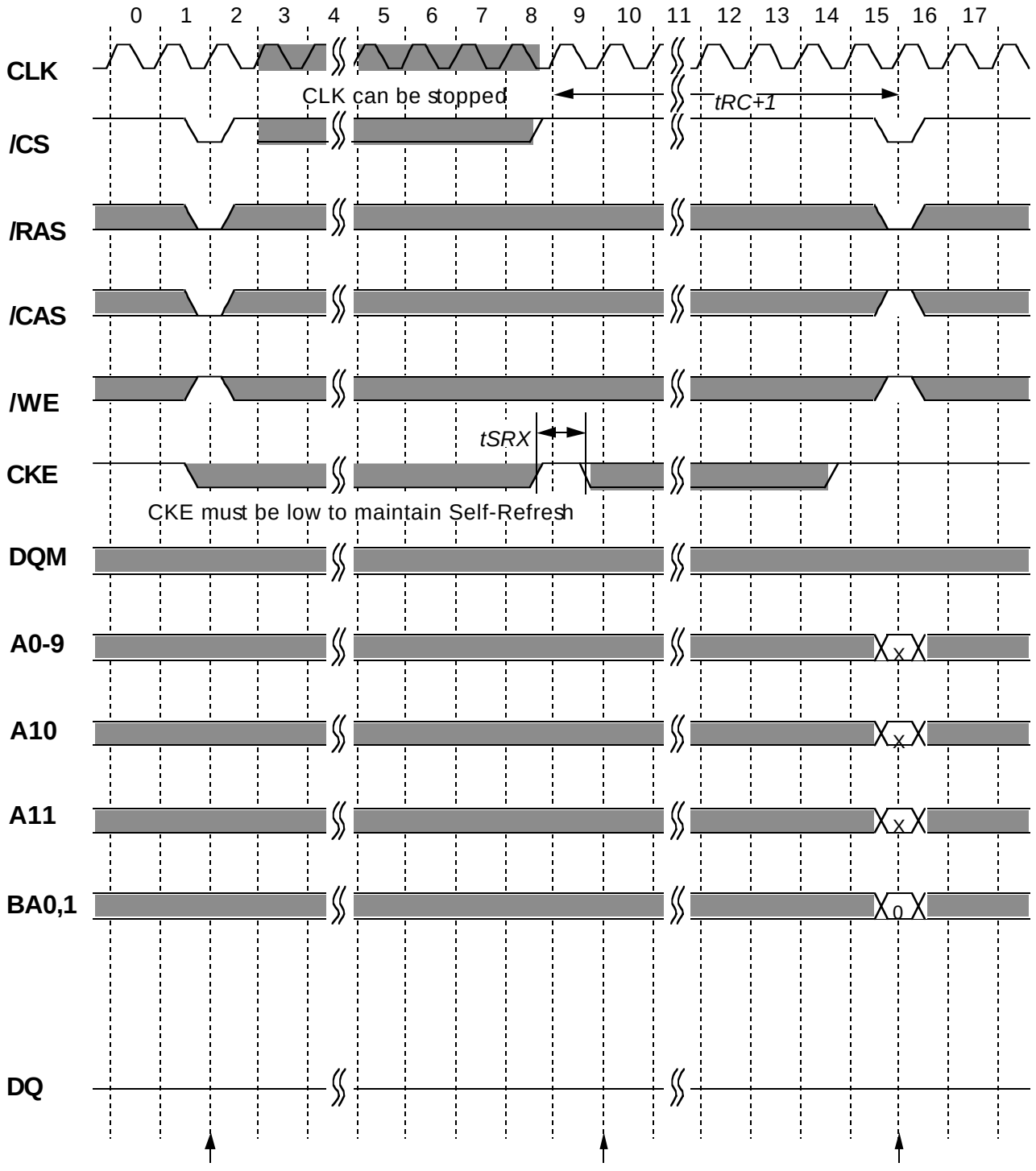
ACT#0

After tRC from Auto-Refresh, all banks are idle state.

WRITE#0

Italic parameter indicates minimum case

Self-Refresh



Self-Refresh Entry

Before Self-Refresh Entry, all banks must be idle state.

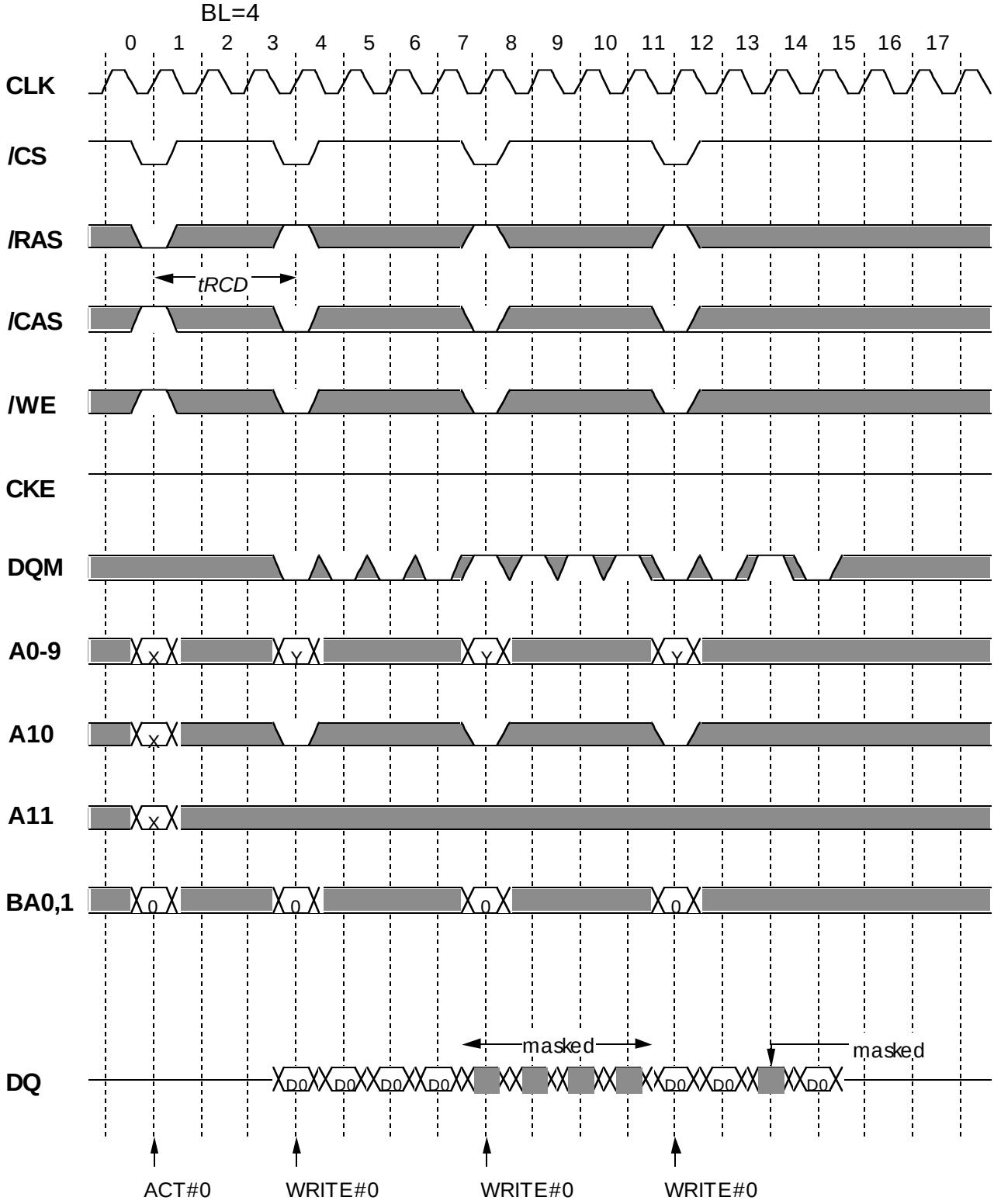
Self-Refresh Exit

After tRC from Self-Refresh Exit, all banks are idle state.

ACT#0

Italic parameter indicates minimum case

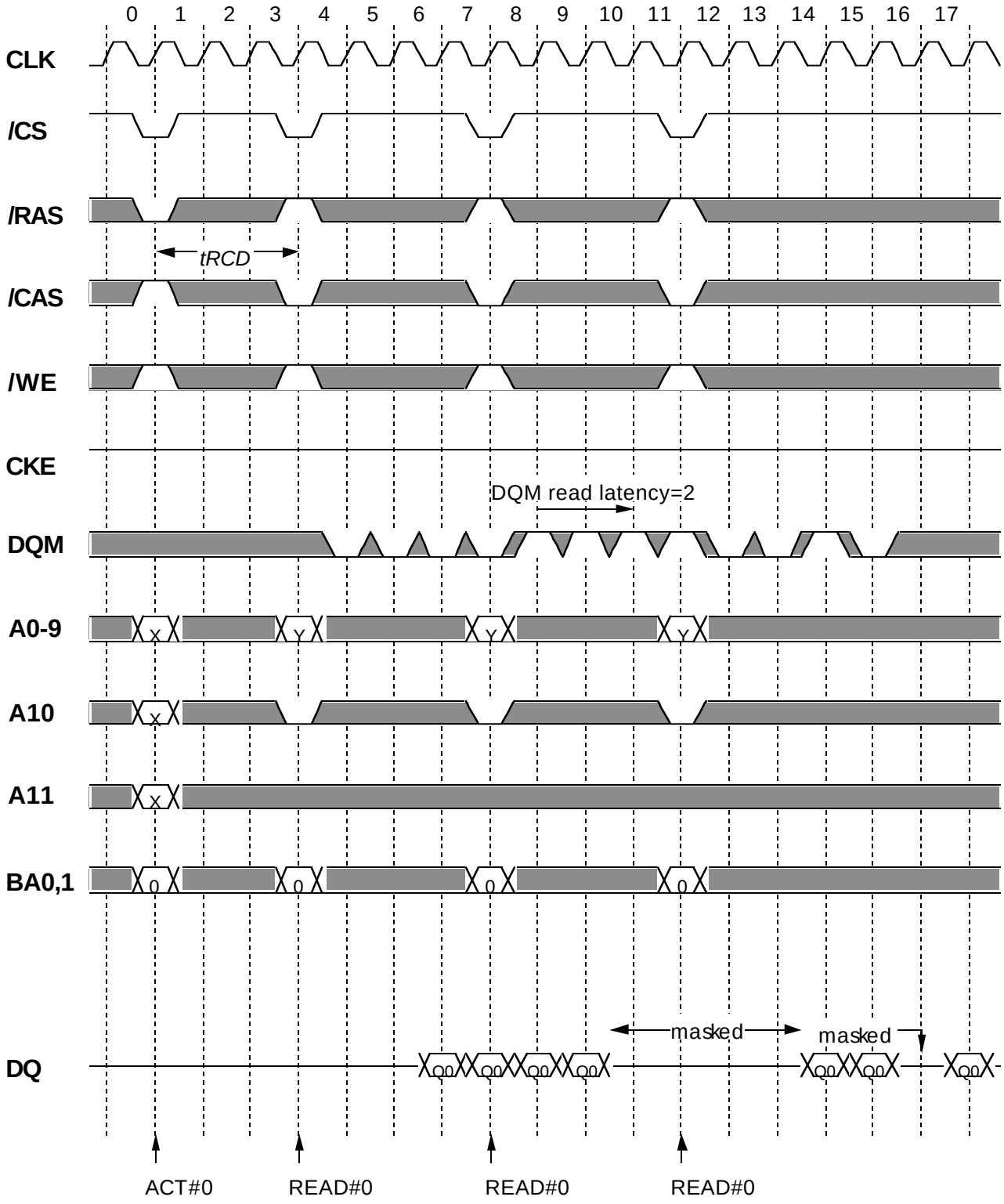
DQM Write Mask



Italic parameter indicates minimum case

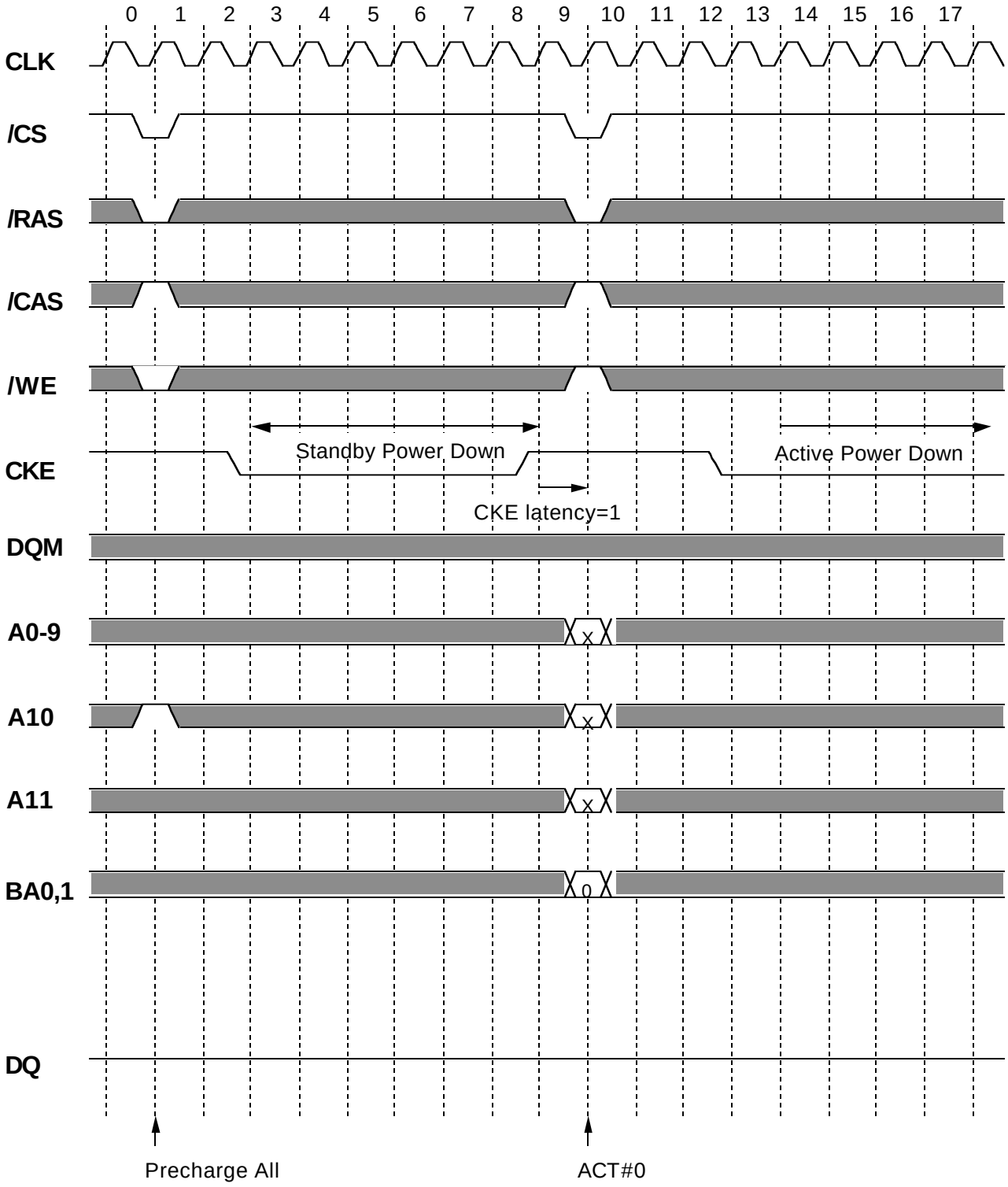
DQM Read Mask

BL=4, CL=3



Italic parameter indicates minimum case

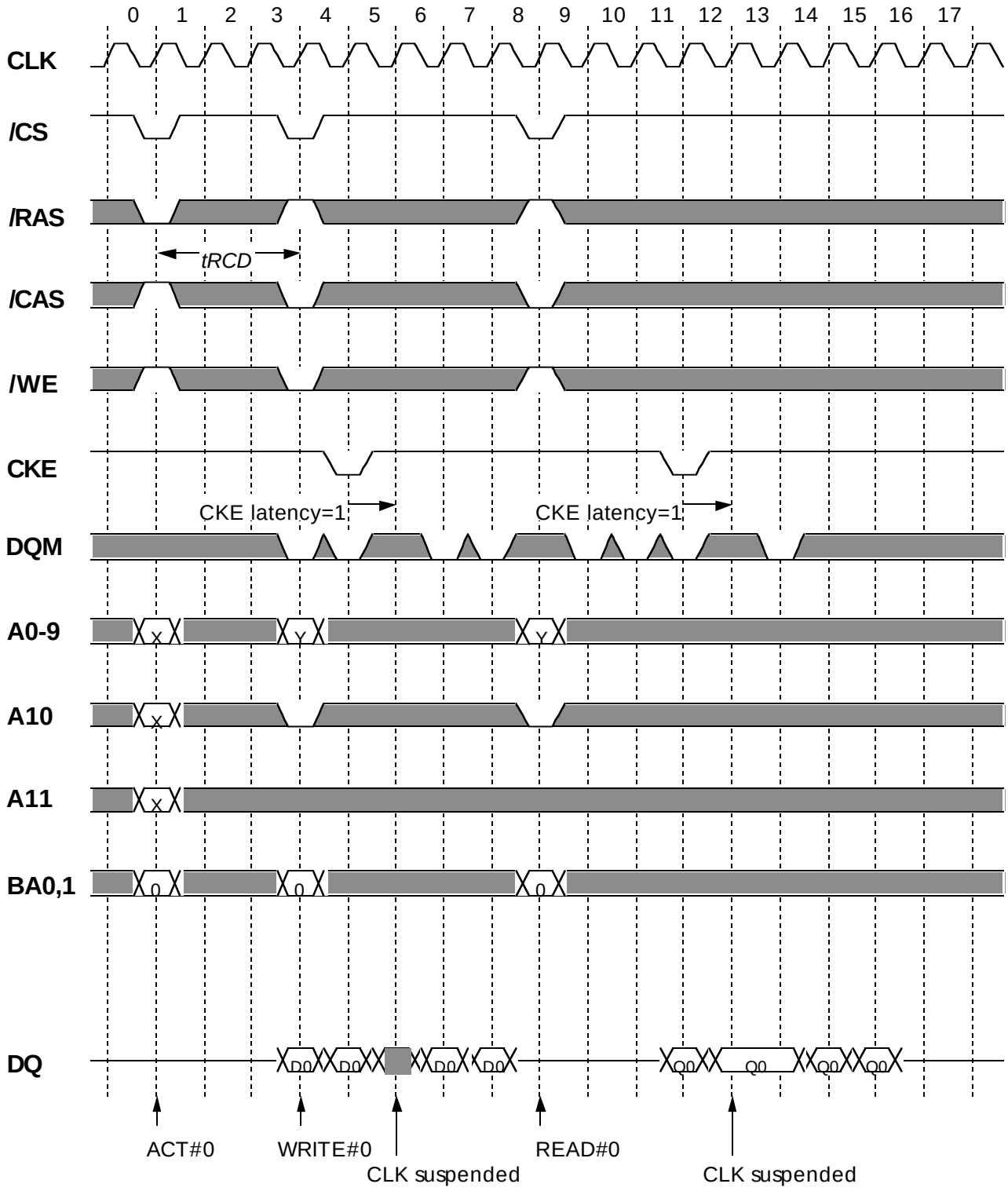
Power Down



Italic parameter indicates minimum case

CLK Suspend

BL=4,CL=3



Italic parameter indicates minimum case

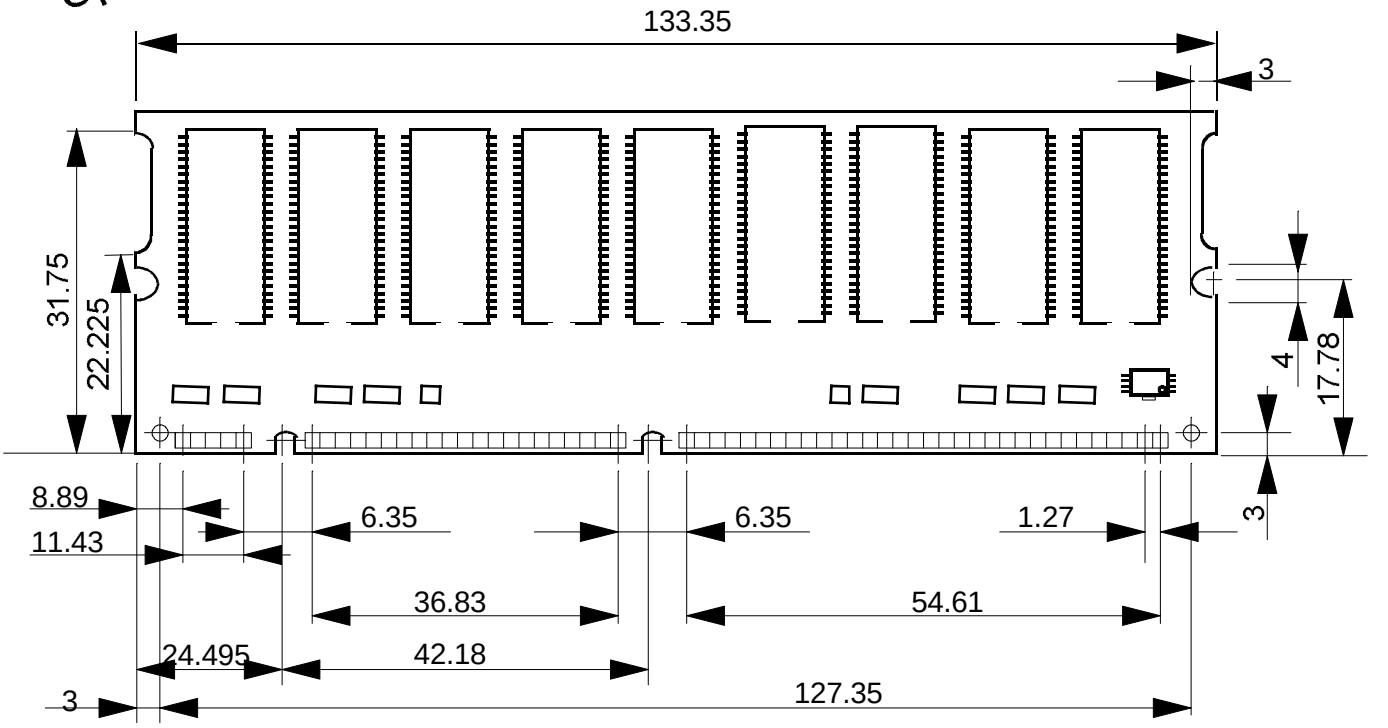
Serial Presence Detect Table I

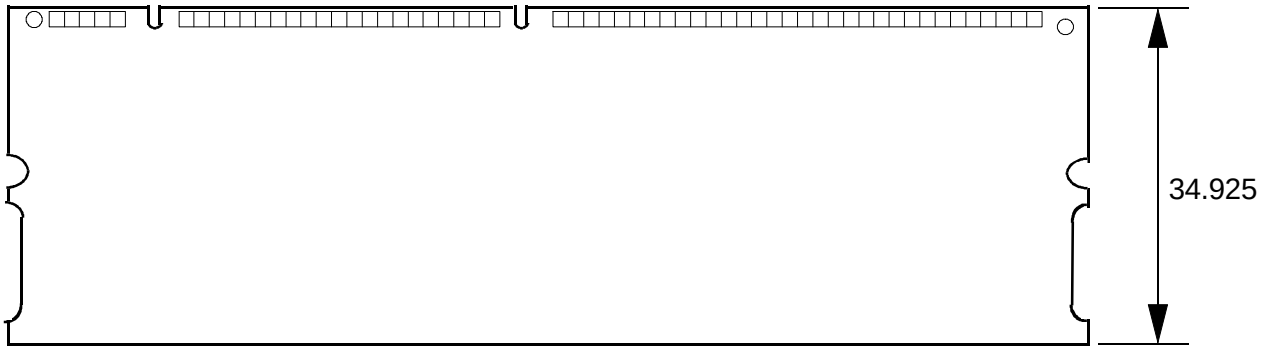
Byte	Function described	SPD enrty data	SPD DATA(hex)
0	# of Serial PD Bytes Written during Production	128	80
1	Total # of Bytes in SPD device	256 Bytes	08
2	Fundamental memory type	SDRAM	04
3	# Row Addresses on this assembly	A0-A11	0C
4	# Column Addresses on this assembly	A0-A8	09
5	# Module Banks on this assembly	1BANK	01
6	Data Width of this assembly...	x72	48
7	... Data Width continuation	0	00
8	Voltage interface standard of this assembly	LVTTL	01
9	SDRAM Cycletime at Max. Supported CAS Latency (CL). Cycle time for CL=3	7.5ns	75
10	SDRAM Access from Clock tAC for CL=3	5.4ns	54
11	DIMM Configuration type (Non-parity,Parity,ECC)	ECC	02
12	Refresh Rate/Type	self refresh(15.625uS)	80
13	SDRAM width,Primary DRAM	x8	08
14	Error Checking SDRAM data width	x8	08
15	Minimum Clock Delay,Back to Back Random Column Addresses	1	01
16	Burst Lengths Supported	1/2/4/8/Full page	8F
17	# Banks on Each SDRAM device	4bank	04
18	CAS# Latency	3	04
19	CS# Latency	0	01
20	Write Latency	0	01
21	SDRAM Module Attributes	unbuffered	00
22	SDRAM Device Attributes:General	Precharge All,Auto precharge Write1/Read Burst	0E
23	SDRAM Cycle time(2nd highest CAS latency) Cycle time for CL=2	N/A	00
24	SDRAM Access form Clock(2nd highest CAS latency) tAC for CL=2	N/A	00
25	SDRAM Cycle time(3rd highest CAS latency)	N/A	00
26	SDRAM Access form Clock(3rd highest CAS latency)	N/A	00
27	Precharge to Active Minimum	23ns(22.5ns)	17
28	Row Active to Row Active Min.	15ns	0F
29	RAS to CAS Delay Min	23ns(22.5ns)	17
30	Active to Precharge Min	45ns	2D

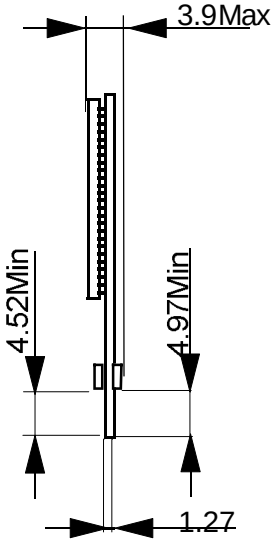
Preliminary Spec.

Serial Presence Detect Table II

31	Density of each bank on module	64MByte	10
32	Command and Address signal input setup time	1.5ns	15
33	Command and Address signal input hold time	0.8ns	08
34	Data signal input setup time	1.5ns	15
35	Data signal input hold time	0.8ns	08
36-61	Superset Information (may be used in future)	option	00
62	SPD Revision	JEDEC2	02
63	Checksum for bytes 0-62		A4
64-71	Manufactures Jedec ID code per JEP-108E	MITSUBISHI	1CFFFFFFFFFFFFFF
72	Manufacturing location	Miyoshi,Japan	01
		Tajima,Japan	02
		NC,USA	03
		Germany	04
73-90	Manufactures Part Number	MH8S72BALD-6	4D483853373242414C442D36202020202020
91-92	Revision Code	PCB revision	rrrr
93-94	Manufacturing date	year/week code	yyww
95-98	Assembly Serial Number	serial number	ssssssss
99-125	Manufacture Specific Data	option	00
126	Intetl specification frequency		64
127	Intel specification CAS# Latency support	CL=3,AP,CK0,2	AD
128+	Unused storage locations	open	00


133.35
3
31.75
22.225
4
17.78
3
8.89
11.43
6.35
6.35
1.27
36.83
54.61
24.495
42.18
3
127.35


34.925


3.9Max
4.52Min
4.97Min
1.27

Preliminary Spec.

MH8S72BALD-6

603,979,776-BIT (8,388,608-WORD BY 72-BIT) Synchronous DYNAMIC RAM

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